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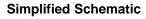
LDC1312-Q1, LDC1314-Q1

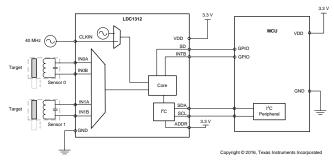
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LDC1312-Q1, LDC1314-Q1 Multi-Channel 12-Bit Inductance to Digital Converter (LDC) for **Inductive Sensing**

Features 1

- Qualified for Automotive Applications
- AEC-Q100 Qualified With the Following Results:
 - Device Temperature Grade 1:-40°C to +125°C Ambient Operating Temperature Range
 - **Device HBM ESD Classification Level 2**
 - Device CDM ESD Classification Level C5
- Easy-to-use Minimal Configuration Required
- Measure up to 4 Sensors with One IC
- Multiple Channels Support Environmental and Aging Compensation
- Multi-Channel Remote Sensing Provides Lowest System Cost
- Pin-Compatible Medium and High-resolution Options
 - LDC1312-Q1/LDC1314-Q1: 2/4-ch 12-bit LDC
 - LDC1612-Q1/LDC1614-Q1: 2/4-ch 28-bit LDC
- Supports Wide Sensor Frequency Range of 1kHz to 10MHz
- Power Consumption:
 - 35 µA Low Power Sleep Mode
 - 200 nA Shutdown Mode
- 3.3V Operation
- Support Internal or External Reference Clock
- Immune to DC Magnetic Fields and Magnets





2 Applications

Tools &

Software

- Automotive Buttons and Knobs •
- Linear and Rotational Encoders
- Slider Buttons •
- Metal Detection in Industrial and Automotive
- Flow Meters

3 Description

The LDC1312-Q1 and LDC1314-Q1 are 2- and 4channel, 12-bit inductance to digital converters (LDCs) for inductive sensing solutions. With multiple channels and support for remote sensing, the LDC1314-Q1 LDC1312-Q1 and enable the performance and reliability benefits of inductive sensing to be realized at minimal cost and power. The products are easy to use, only requiring that the sensor frequency be within 1 kHz and 10 MHz to begin sensing. The wide 1 kHz to 10 MHz sensor frequency range also enables use of very small PCB coils, further reducing sensing solution cost and size.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|-------------|-----------|-------------------|
| LDC1312-Q1 | WSON (12) | 4.00 mm × 4.00 mm |
| LDC1314-Q1 | WQFN (16) | 4.00 mm × 4.00 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Measurement Precision vs. Target Distance

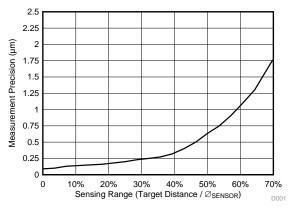


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4 Revision History

| DATE | REVISION | NOTES |
|------------|----------|------------------|
| April 2016 | * | Initial release. |

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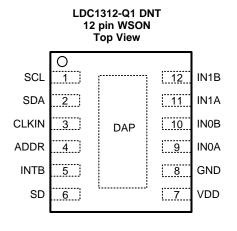
5 Description Continued

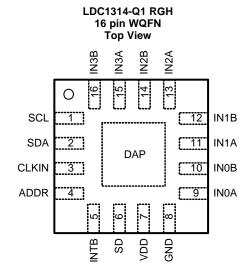
The LDC1312-Q1 and LDC1314-Q1 offer well-matched channels, which allow for differential and ratiometric measurements. This enables designers to use one channel to compensate their sensing for environmental and aging conditions such as temperature, humidity, and mechanical drift. Given their ease of use, low power, and low system cost these products enable designers to greatly improve on existing sensing solutions and to introduce brand new sensing capabilities to products in all markets, especially consumer and industrial applications. Inductive sensing offers better performance, reliability, and flexibility than competitive sensing technologies at lower system cost and power.

The LDC1312-Q1 and LDC1314-Q1 are easily configured via an I2C interface. The two-channel LDC1312-Q1 is available in a WSON-12 package and the four-channel LDC1314-Q1 is available in a WQFN-16 package.



6 Pin Configuration and Functions





Pin Functions

| I | PIN | TYPE ⁽¹⁾ | DESCRIPTION |
|-----|--------------------|---------------------|--|
| NO. | NAME | ITPE'' | DESCRIPTION |
| 1 | SCL | I | I2C Clock input |
| 2 | SDA | I/O | I2C Data input/output |
| 3 | CLKIN | I | Master Clock input. Tie this pin to GND if internal oscillator is selected |
| 4 | ADDR | I | I2C Address selection pin: when ADDR=L, I2C address = 0x2A, when ADDR=H, I2C address = 0x2B. |
| 5 | INTB | 0 | Configurable Interrupt output pin |
| 6 | SD | I | Shutdown input |
| 7 | VDD | Р | Power Supply |
| 8 | GND | G | Ground |
| 9 | IN0A | А | External LC sensor 0 connection |
| 10 | IN0B | А | External LC sensor 0 connection |
| 11 | IN1A | А | External LC sensor 1 connection |
| 12 | IN1B | А | External LC sensor 1 connection |
| 13 | IN2A | А | External LC sensor 2 connection (LDC1314 only) |
| 14 | IN2B | А | External LC sensor 2 connection (LDC1314 only) |
| 15 | IN3A | А | External LC sensor 3 connection (LDC1314 only) |
| 16 | IN3B | А | External LC sensor 3 connection (LDC1314 only) |
| DAP | DAP ⁽²⁾ | N/A | Connect to Ground |

(1) I = Input, O = Output, P=Power, G=Ground, A=Analog

(2) There is an internal electrical connection between the exposed Die Attach Pad (DAP) and the GND pin of the device. Although the DAP can be left floating, for best performance the DAP should be connected to the same potential as the device's GND pin. Do not use the DAP as the primary ground for the device. The device GND pin must always be connected to ground.



7 Specifications

7.1 Absolute Maximum Ratings

| | | MIN | MAX | UNIT |
|------------------|----------------------------------|------|---------|------|
| V _{DD} | Supply Voltage | | 5 | V |
| Vi | Voltage on any pin | -0.3 | VDD+0.3 | V |
| IA | Input current on any INx pin | -8 | 8 | mA |
| ID | Input current on any Digital pin | -5 | 5 | mA |
| Tj | Junction Temperature | -55 | 150 | °C |
| T _{stg} | Storage temperature range | -65 | 150 | °C |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

| | | | VALUE | UNIT |
|--------|-------------------------|---|-------|------|
| V | Flastrastatia disabaras | Human-body model (HBM), per AEC Q100-002 ⁽¹⁾ | ±2000 | N/ |
| V(ESD) | Electrostatic discharge | Charged-device model (CDM), per AEC Q100-011 | ±750 | v |

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

7.3 Recommended Operating Conditions

Unless otherwise specified, all limits ensured for $T_A = 25^{\circ}C$, VDD = 3.3 V

| | | MIN | NOM MAX | UNIT |
|----------------|-----------------------|-----|---------|------|
| VDD | Supply Voltage | 2.7 | 3.6 | V |
| T _A | Operating Temperature | -40 | 125 | °C |

7.4 Thermal Information

| | | LDC1312 | LDC1314 | |
|-----------------------|--|------------|------------|------|
| | THERMAL METRIC ⁽¹⁾ | DNT (WSON) | RGH (WQFN) | UNIT |
| | | 12 PINS | 16 PINS | |
| R _{0JA} | Junction-to-ambient thermal resistance | 36.7 | 35.6 | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | 36.2 | 36.2 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 14 | 13.4 | °C/W |
| ΨJT | Junction-to-top characterization parameter | 0.4 | 0.4 | °C/W |
| Ψјв | Junction-to-board characterization parameter | 14.2 | 13.4 | °C/W |
| R _{0JC(bot)} | Junction-to-case (bottom) thermal resistance | 3.5 | 3.5 | °C/W |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

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7.5 Electrical Characteristics ⁽¹⁾

Unless otherwise specified, all limits ensured for $T_A = 25^{\circ}C$, VDD = 3.3 V

| | PARAMETER | TEST CONDITIONS ⁽²⁾ | MIN ⁽³⁾ | TYP ⁽⁴⁾ | MAX ⁽³⁾ | UNIT |
|---------------------------|--|---|--------------------|--------------------|--------------------|--------|
| POWER | | | | | | |
| V _{DD} | Supply Voltage | $T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C$ | 2.7 | | 3.6 | V |
| I _{DD} | Supply Current (not including sensor current) ⁽⁵⁾ | CLKIN = 10MHz ⁽⁶⁾ | | 2.1 | | mA |
| IDDSL | Sleep Mode Supply Current ⁽⁵⁾ | | | 35 | 60 | μA |
| I _{SD} | Shutdown Mode Supply Current ⁽⁵⁾ | | | 0.2 | 1 | μA |
| SENSOR | | | | | | |
| ISENSORMAX | Sensor Maximum Current drive | HIGH_CURRENT_DRV = b0 | | 1.5 | | mA |
| R _P | Sensor R _P | DRIVE_CURRENT_CHx = 0xF800 | 1 | | 100 | kΩ |
| IHD _{SENSORMAX} | High current sensor drive mode: Sensor Maximum Current | HIGH_CURRENT_DRV = b1 DRIVE_CURRENT_CH0 = 0xF800 | | 6 | | mA |
| R _{P_HD_MIN} | Minimum sensor R _P | Channel 0 only | | 250 | | Ω |
| f _{SENSOR} | Sensor Resonance Frequency | $T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C$ | 0.001 | | 10 | MHz |
| VSENSORMAX | Maximum oscillation amplitude (peak) | | | 1.8 | | V |
| N _{BITS} | Number of bits | RESET_DEV.OUTPUT_GAIN=b00 | | | 40 | h:+- |
| | | RCOUNT ≥ 0x0400 | | | 12 | bits |
| f _{CS} | Maximum Channel Sample Rate | single active channel continuous conversion, SCL=400kHz | | | 13.3 | kSPS |
| C _{IN} | Sensor Pin input capacitance | | | 4 | | pF |
| MASTER CLOCK | (| • | | | ÷ | |
| f _{CLKIN} | External Master Clock Input Frequency (CLKIN) | $T_A = -40^{\circ}C \text{ to } +125^{\circ}C$ | 2 | | 40 | MHz |
| CLKIN _{DUTY_MIN} | External Master Clock minimum acceptable duty cycle (CLKIN) | | | 40% | | |
| CLKIN _{DUTY_MAX} | External Master Clock maximum acceptable duty cycle (CLKIN) | | | 60% | | |
| V _{CLKIN_LO} | CLKIN low voltage threshold | | | | 0.3×VDD | V |
| V _{CLKIN_} HI | CLKIN high voltage threshold | | 0.7×VD D | | | V |
| fINTCLK | Internal Master Clock Frequency range | | 35 | 43.4 | 55 | MHz |
| T _{Cf_int_µ} | Internal Master Clock Temperature Coefficient mean | | | -13 | | ppm/°C |

(1) Electrical Characteristics Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that TJ = TA. Absolute Maximum Ratings indicate junction temperature limits beyond which the device may be permanently degraded, either mechanically or electrically.

(2) Register values are represented as either binary (b is the prefix to the digits), or hexadecimal (0x is the prefix to the digits). Decimal values have no prefix.

(3) Limits are ensured by testing, design, or statistical analysis at 25°C. Limits over the operating temperature range are ensured through correlations using statistical quality control (SQC) method.

(4) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

(5) I2C read/write communication and pullup resistors current through SCL, SDA not included.

(6) Sensor inductor: 2 layer, 32 turns/layer, 14mm diameter, PCB inductor with L=19.4 µH, R_P=5.7 kΩ at 2MHz Sensor capacitor: 330 pF 1% COG/NP0 Target: Aluminum, 1.5mm thickness Channel = Channel 0 (continuous mode) CLKIN = 40 MHz, CHx_FIN_DIVIDER = b00000, CHx_FREF_DIVIDER = b00 0000 0001 CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100 RP_OVERRIDE = b1, AUTO_AMP_DIS = b1, DRIVE_CURRENT_CH0 = 0x9800



7.6 Timing Characteristics

| | | MIN | NOM | MAX | UNIT |
|-------------------------|--|-----|-----|-----|------|
| t _{WAKEUP} | Wake-up Time from SD high-low transition to I2C readback | | | 2 | ms |
| t _{WD-TIMEOUT} | Sensor recovery time (after watchdog timeout) | | 5.2 | | ms |

7.7 Switching Characteristics - I2C

Unless otherwise specified, all limits ensured for T_{A} = 25°C, VDD = 3.3 V

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------|--|---|---------------------|---------------------|---------------------|------|
| VOLTAGE L | EVELS | • | | | | |
| V _{IH} | Input High Voltage | | $0.7 \times V_{DD}$ | | | V |
| V _{IL} | Input Low Voltage | | | | $0.3 \times V_{DD}$ | V |
| V _{OL} | Output Low Voltage (3mA sink current) | | | | 0.4 | V |
| HYS | Hysteresis | | | 0.1×V _{DD} | | V |
| I2C TIMING | CHARACTERISTICS | • | * | | | |
| f _{SCL} | Clock Frequency | | 10 | | 400 | kHz |
| t _{LOW} | Clock Low Time | | 1.3 | | | μs |
| t _{HIGH} | Clock High Time | | 0.6 | | | μs |
| t _{HD;STA} | Hold Time (repeated) START condition | After this period, the first clock pulse is generated | 0.6 | | | μs |
| t _{SU;STA} | Set-up time for a repeated START condition | | 0.6 | | | μs |
| t _{HD;DAT} | Data hold time | | 0 | | | μs |
| t _{SU;DAT} | Data setup time | | 100 | | | ns |
| t _{SU;STO} | Set-up time for STOP condition | | 0.6 | | | μs |
| t _{BUF} | Bus free time between a STOP and START condition | | 1.3 | | | μs |
| t _{VD;DAT} | Data valid time | | | | 0.9 | μs |
| t _{VD;ACK} | Data valid acknowledge time | | | | 0.9 | μs |
| t _{SP} | Pulse width of spikes that must be suppressed by the input filter ⁽¹⁾ | | | | 50 | ns |

(1) This parameter is specified by design and/or characterization and is not tested in production.

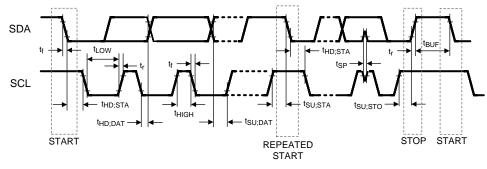
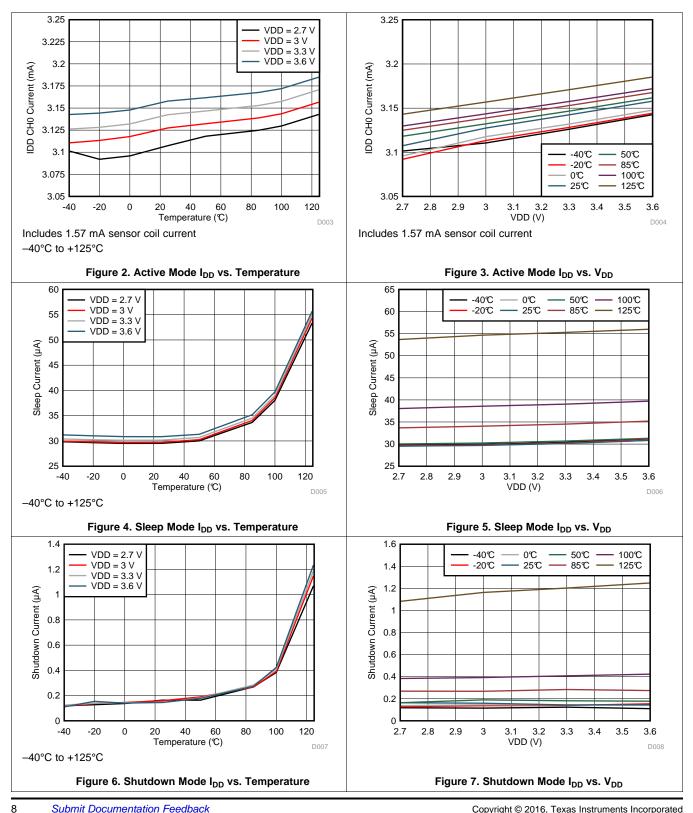


Figure 1. I2C Timing



7.8 Typical Characteristics

Common test conditions (unless specified otherwise): Sensor inductor: 2 layer, 32 turns/layer, 14 mm diameter, PCB inductor with L=19.4 μH, R_P=5.7 kΩ at 2 MHz; Sensor capacitor: 330 pF 1% COG/NP0; Target: Aluminum, 1.5mm thickness; Channel = Channel 0 (continuous mode); CLKIN = 40 MHz, CHx_FIN_DIVIDER = 0x1, CHx_FREF_DIVIDER = 0x001, CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100, RP_OVERRIDE = 1, AUTO_AMP_DIS = 1, DRIVE_CURRENT_CH0 = 0x9800



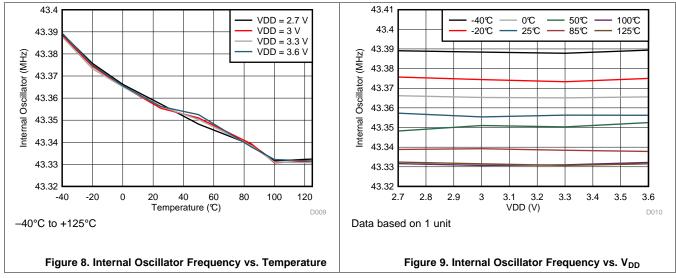
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Typical Characteristics (continued)

Common test conditions (unless specified otherwise): Sensor inductor: 2 layer, 32 turns/layer, 14 mm diameter, PCB inductor with L=19.4 μ H, R_P=5.7 k Ω at 2 MHz; Sensor capacitor: 330 pF 1% COG/NP0; Target: Aluminum, 1.5mm thickness; Channel = Channel 0 (continuous mode); CLKIN = 40 MHz, CHx_FIN_DIVIDER = 0x1, CHx_FREF_DIVIDER = 0x001, CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100, RP_OVERRIDE = 1, AUTO_AMP_DIS = 1, DRIVE_CURRENT_CH0 = 0x9800

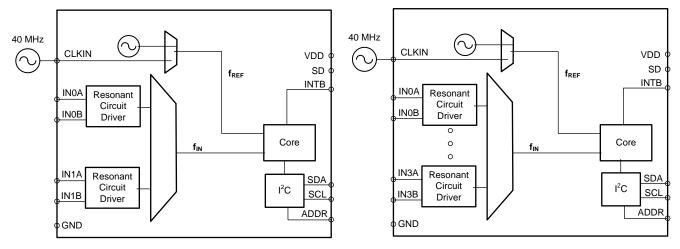


8 Detailed Description

8.1 Overview

Conductive objects brought in contact with an AC electromagnetic (EM) field will induce field changes that can be detected using a sensor such as an inductor. Conveniently, an inductor, along with a capacitor, can be used to construct an L-C resonator, also known as an L-C tank, which can be used to produce an EM field. In the case of an L-C tank, the effect of the field disturbance is an apparent shift in the inductance of the sensor, which can be observed as a shift in the resonant frequency. Using this principle, the LDC1312/1314 is an inductance-to-digital converter (LDC) that measures the oscillation frequency of an LC resonator. The device outputs a digital value that is proportional to frequency. This frequency measurement can be converted to an equivalent inductance.

8.2 Functional Block Diagram



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Figure 10. Block Diagrams for the LDC1312 (Left) and LDC1314 (Right)

The LDC1312/LDC1314 is composed of front-end resonant circuit drivers, followed by a multiplexer that sequences through the active channels, connecting them to the core that measures and digitizes the sensor frequency (f_{SENSOR}). The core uses a reference frequency (f_{REF}) to measure the sensor frequency. f_{REF} is derived from either an internal reference clock (oscillator), or an externally supplied clock. The digitized output for each channel is proportional to the ratio of f_{SENSOR}/f_{REF} . The I2C interface is used to support device configuration and to transmit the digitized frequency values to a host processor. The LDC can be placed in shutdown mode, saving current, using the SD pin. The INTB pin may be configured to notify the host of changes in system status.

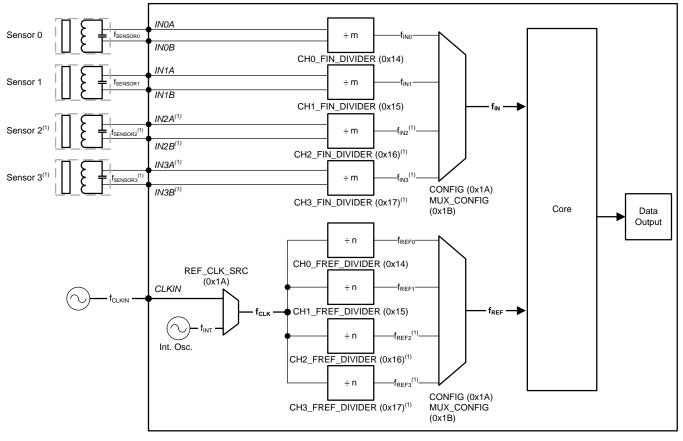
8.3 Feature Description

8.3.1 Clocking Architecture

Figure 11 shows the clock dividers and multiplexers of the LDC.



Feature Description (continued)



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(1) LDC1314 only

In Figure 11, the key clocks are f_{IN} , f_{REF} , and f_{CLK} . f_{CLK} is selected from either the internal clock source or external clock source (CLKIN). The frequency measurement reference clock, f_{REF} , is derived from the f_{CLK} source. TI recommends that precision applications use an external master clock that offers the stability and accuracy requirements needed for the application. The internal oscillator may be used in applications that require lock cost and do not require high precision. The f_{INx} clock is derived from sensor frequency for a channel x, $f_{SENSORx}$. f_{REFx} and f_{INx} must meet the requirements listed in Table 1, depending on whether f_{CLK} (master clock) is the internal or external clock.

| Table 1. Clock | Configuration | Requirements |
|----------------|---------------|--------------|
|----------------|---------------|--------------|

| MODE ⁽¹⁾ | CLKIN SOURCE | VALID f _{REFx} RANGE (MHz) | VALID f _{INx} RANGE | SET CHx_FIN_DIVIDE R to | SET CHx_SETTLECO UNT to | SET CHx_RCOUNT to |
|---------------------|-----------------------------|--|---------------------------------|-------------------------------|-------------------------------|----------------------|
| Multi-Channel | Internal | $f_{REFx} < 55$ | | | | |
| | External | $f_{REFx} < 40$ | < f _{REFx} /4 | ≥ b0001 ⁽²⁾ | > 3 | > 8 |
| Single-Channel | Either external or internal | f _{REFx} < 35 | Y INEFX / T | - 50001 | 2.0 | 20 |

(1) Channels 2 and 3 are only available for LDC1314

(2) If $f_{SENSOR} \ge 8.75$ MHz, then CHx_FIN_DIVIDER must be ≥ 2

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Table 2 shows the clock configuration registers for all channels.

| CHANNEL ⁽¹⁾ | CLOCK | REGISTER | FIELD [BIT(S)] | VALUE |
|------------------------|---|-----------------------------------|-------------------------|--|
| All | f _{CLK} = Master Clock Source | CONFIG, addr 0x1A | REF_CLK_SRC [9] | b0 = internal oscillator is used as the master clock b1 = external clock source is used as the master clock |
| 0 | f _{REF0} | CLOCK_DIVIDER S_CH0, addr 0x14 | CH0_FREF_DIVIDER [9:0] | $f_{REF0} = f_{CLK} / CH0_FREF_DIVIDER$ |
| 1 | f _{REF1} | CLOCK_DIVIDER S_CH1, addr 0x15 | CH1_FREF_DIVIDER [9:0] | $f_{REF1} = f_{CLK} / CH1_FREF_DIVIDER$ |
| 2 | f _{REF2} | CLOCK_DIVIDER S_CH2, addr 0x16 | CH2_FREF_DIVIDER [9:0] | $f_{REF2} = f_{CLK} / CH2_FREF_DIVIDER$ |
| 3 | f _{REF3} | CLOCK_DIVIDER S_CH3, addr 0x17 | CH3_FREF_DIVIDER [9:0] | $f_{REF3} = f_{CLK} / CH3_FREF_DIVIDER$ |
| 0 | f _{INO} | CLOCK_DIVIDER S_CH0, addr 0x14 | CH0_FIN_DIVIDER [15:12] | $f_{IN0} = f_{SENSOR0} / CH0_FIN_DIVIDER$ |
| 1 | f _{IN1} | CLOCK_DIVIDER S_CH1, addr 0x15 | CH1_FIN_DIVIDER [15:12] | $f_{IN1} = f_{SENSOR1} / CH1_FIN_DIVIDER$ |
| 2 | f _{IN2} | CLOCK_DIVIDER S_CH2, addr 0x16 | CH2_FIN_DIVIDER [15:12] | $f_{IN2} = f_{SENSOR2} / CH2_FIN_DIVIDER$ |
| 3 | f _{IN3} | CLOCK_DIVIDER S_CH3, addr 0x17 | CH3_FIN_DIVIDER [15:12] | $f_{IN3} = f_{SENSOR3} / CH3_FIN_DIVIDER$ |

Table 2. Clock Configuration Registers

(1) Channels 2 and 3 are only available for LDC1314

8.3.2 Multi-Channel and Single Channel Operation

The multi-channel package of the LDC enables the user to save board space and support flexible system design. For example, temperature drift can often cause a shift in component values, resulting in a shift in resonant frequency of the sensor. Using a 2nd sensor as a reference provides the capability to cancel out a temperature shift. When operated in multi-channel mode, the LDC sequentially samples the active channels. In single channel mode, the LDC samples a single channel, which is selectable. Table 3 shows the registers and values that are used to configure either multi-channel or single channel modes.

| | U | 0 0 | |
|----------------|----------------------|---------------------|--|
| MODE | REGISTER | FIELD [BIT(S)] | VALUE ⁽¹⁾ |
| | | ACTIVE_CHAN [15:14] | 00 = chan 0 |
| | CONFIG, addr 0x1A | | 01 = chan 1 |
| Single channel | CONFIG, addi 0x1A | | 10 = chan 2 |
| | | | 11 = chan 3 |
| | MUX_CONFIG addr 0x1B | AUTOSCAN_EN [15] | 0 = continuous conversion on a single channel (default) |
| Multi-channel | MUX_CONFIG addr 0x1B | AUTOSCAN_EN [15] | 1 = continuous conversion on multiple channels |
| | | | 00 = Ch0, Ch 1 |
| | MUX_CONFIG addr 0x1B | RR_SEQUENCE [14:13] | 01 = Ch0, Ch 1, Ch 2 |
| | | | 10 = Ch0, CH1, Ch2, Ch3 |

Table 3. Single and Multi-Channel Configuration Registers

(1) Channels 2 and 3 are only available for LDC1314

The digitized sensor measurement for each channel (DATAx) represents the ratio of the sensor frequency to the reference frequency. The data outputs represent the 12 MSBs of a 16-bit result:

DATAx/
$$2^{12} = f_{SENSORx}/f_{REFx}$$

The sensor frequency can be calculated from:

$$f_{\text{sensorx}} = \frac{\text{DATAx} * f_{\text{REFx}}}{2^{12}}$$

(1)



(3)

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Table 4 shows the registers that contain the fixed point sample values for each channel.

| CHANNEL ⁽¹⁾ | REGISTER | FIELD NAME [BITS(S)] | VALUE |
|------------------------|-------------------------|----------------------|--|
| 0 | DATA_MSB_CH0, addr 0x00 | DATA0 [11:0] | 12 bits of the 16 bit result. 0x000 = under range 0xfff = over range |
| 1 | DATA_MSB_CH1, addr 0x02 | DATA1 [11:0] | 12 bits of the 16 bit result. 0x000 = under range 0xfff = over range |
| 2 | DATA_MSB_CH2, addr 0x04 | DATA2 [11:0] | 12 bits of the 16 bit result. 0x000 = under range 0xfff = over range |
| 3 | DATA_MSB_CH3, addr 0x06 | DATA3 [11:0] | 12 bits of the 16 bit result. 0x000 = under range 0xfff = over range |

(1) Channels 2 and 3 available for LDC1314 only.

When the LDC sequences through the channels in multi-channel mode, the dwell time interval for each channel is the sum of 3 parts: sensor activation time + conversion time + channel switch delay.

The sensor activation time is the amount of settling time required for the sensor oscillation to stabilize, as shown in Figure 12. The settling wait time is programmable and should be set to a value that is long enough to allow stable oscillation. The settling wait time for channel x is given by:

t_{Sx} = (CHX_SETTLECOUNT×16)/f_{REFx}

Table 5 shows the registers and values for configuring the settling time for each channel.

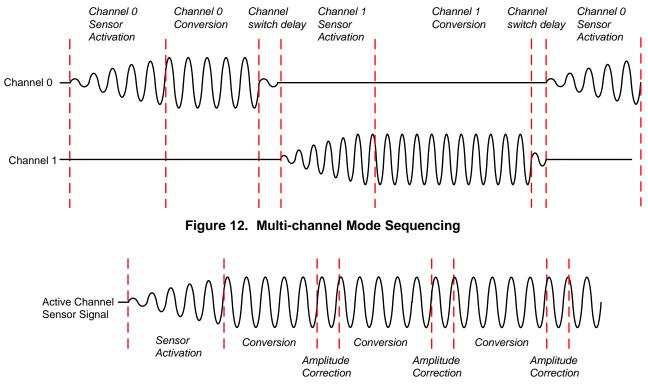


Figure 13. Single-channel Mode Sequencing

(6)

(7)

| CHANNEL ⁽¹⁾ | REGISTER | FIELD | CONVERSION TIME ⁽²⁾ |
|------------------------|----------------------------|------------------------|--|
| 0 | SETTLECOUNT_CH0, addr 0x10 | CH0_SETTLECOUNT (15:0) | (CH0_SETTLECOUNT*16)/f _{REF0} |
| 1 | SETTLECOUNT_CH1, addr 0x11 | CH1_SETTLECOUNT (15:0) | (CH1_SETTLECOUNT*16)/f _{REF1} |
| 2 | SETTLECOUNT_CH2, addr 0x12 | CH2_SETTLECOUNT (15:0) | (CH2_SETTLECOUNT*16)/f _{REF2} |
| 3 | SETTLECOUNT_CH3, addr 0x13 | CH3_SETTLECOUNT (15:0) | (CH3_SETTLECOUNT*16)/f _{REF3} |

(1) Channels 2 and 3 are available only in the LDC1314.

(2) f_{REFx} is the reference frequency configured for the channel.

The SETTLECOUNT for any channel x must satisfy:

 $CHx_SETTLECOUNT \ge Q_{SENSORx} \times f_{REFx} / (16 \times f_{SENSORx})$

where

- f_{SENSORx} = Frequency of the Sensor on Channel x
- f_{REFx} = Reference frequency for Channel x
- Q_{SENSORx} = Quality factor of the sensor on Channel x, where Q can be calculated by: (4)

$$Q = R_{P} \sqrt{\frac{C}{L}}$$
(5)

Round the result to the next highest integer (for example, if Equation 4 recommends a minimum value of 6.08, program the register to 7 or higher).

L, R_P and C values can be obtained by using Texas Instrument's WEBENCH[®] for the coil design.

The conversion time represents the number of reference clock cycles used to measure the sensor frequency. It is set by the CHx_RCOUNT register for the channel. The conversion time for any channel x is:

 $t_{Cx} = (CHx_RCOUNT \times 16 + 4) / f_{REFx}$

The reference count value must be chosen to support the required number of effective bits (ENOB). For details, refer to the application note Optimizing L Measurement Resolution for the LDC161x and LDC1101.

| | | J | |
|---------|-----------------------|-------------------|-----------------------------------|
| CHANNEL | REGISTER | FIELD [BIT(S)] | CONVERSION TIME |
| 0 | RCOUNT_CH0, addr 0x08 | CH0_RCOUNT (15:0) | (CH0_RCOUNT*16)/f _{REF0} |
| 1 | RCOUNT_CH1, addr 0x09 | CH1_RCOUNT (15:0) | (CH1_RCOUNT*16)/f _{REF1} |
| 2 | RCOUNT_CH2, addr 0x0A | CH2_RCOUNT (15:0) | (CH2_RCOUNT*16)/f _{REF2} |
| 3 | RCOUNT_CH3, addr 0x0B | CH3_RCOUNT (15:0) | (CH3_RCOUNT*16)/f _{REF3} |

Table 6. Conversion Time Configuration Registers, Channels 0 - 3⁽¹⁾

(1) Channels 2 and 3 are available only for LDC1314.

The typical channel switch delay time between the end of conversion and the beginning of sensor activation of the subsequent channel is:

Channel Switch Delay = 692 ns + 5 / f_{ref}

The deterministic conversion time of the LDC allows data polling at a fixed interval. A data ready flag (DRDY) is also available for interrupt driven system designs (see the STATUS register description in *Register Maps*).

An offset value may be subtracted from each DATA value to compensate for a frequency offset or maximize the dynamic range of the sample data. The offset values should be < $f_{SENSORx_MIN} / f_{REFx}$. Otherwise, the offset might be so large that it masks the LSBs which are changing.

| CHANNEL (1) | REGISTER | FIELD [BIT(S)] | VALUE |
|-------------|-----------------------|---------------------|--|
| 0 | OFFSET_CH0, addr 0x0C | CH0_OFFSET [15:0] | $f_{OFFSET0} = CH0_OFFSET * (f_{REF0}/2^{16})$ |
| 1 | OFFSET_CH1, addr 0x0D | CH1_OFFSET [15:0] | $f_{OFFSET1} = CH1_OFFSET * (f_{REF1}/2^{16})$ |
| 2 | OFFSET_CH2, addr 0x0E | CH2_OFFSET [15:0] | $f_{OFFSET2} = CH2_OFFSET * (f_{REF2}/2^{16})$ |
| 3 | OFFSET_CH3, addr 0x0F | CH3_OFFSET [15:0] | $f_{OFFSET3} = CH3_OFFSET * (f_{REF3}/2^{16})$ |

Table 7. Frequency Offset Registers

(1) Channels 2 and 3 are only available for LDC1314

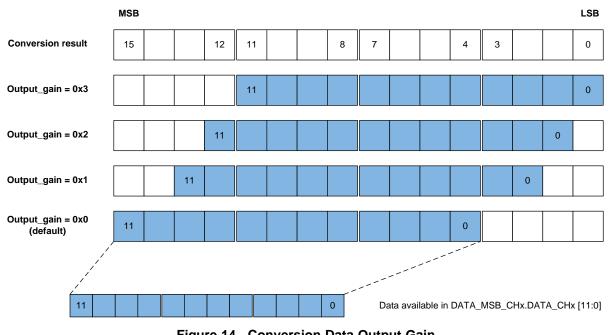
Internally, the LDC measures with 16bits of resolution, while the conversion output word width is only 12bits. For systems in which the sensor signal variation is less than 25% of the full scale range, the LDC can report conversion results with higher resolution by setting the output gain. The output gain is applied to all device channels. An output gain can be used to apply a 2-bit, 3-bit, or 4-bit shift to the output code for all channels, allowing access to the 4LSBs of the original 16-bit result. The MSBs of the sample are shifted out when a gain is applied. Do not use the output gain if the MSBs of any active channel are toggling, as the MSBs for that channel will be lost when gain is applied.

| CHANNEL (1) | REGISTER | FIELD [BIT(S)] | VALUES | EFFECTIVE RESOLUTION (BITS) | OUTPUT RANGE |
|-------------|-------------------------|----------------------|---|--------------------------------|------------------|
| All | RESET_DEV, addr 0x1C | OUTPUT_GAIN [10:9] | 00 (default): Gain =1 (0 bits shift) | 12 | 100% full scale |
| | | | 01: Gain = 4 (2 bits left shift) | 14 | 25% full scale |
| | | | 10: Gain = 8 (3 bits left shift) | 15 | 12.5% full scale |
| | | | 11 : Gain = 16 (4 bits left shift) | 16 | 6.25% full scale |

Table 8. Output Gain Register

(1) Channels 2 and 3 are available for LDC1314 only.

Example: If the conversion result for a channel is 0x07A3, with OUTPUT_GAIN=0x0, the reported output code is 0x07A. If OUTPUT_GAIN is set to 0x3 in the same condition, then the reported output code is 0x7A3. The original 4 MSBs (0x0) are no longer accessible. Figure 14 shows the segments of the 16-bit sample that is reported for each possible gain setting.





The sensor frequency can be determined by:

$$f_{\text{SENSORx}} = \text{CHx}_{\text{FIN}} \text{DIVIDER} * f_{\text{REFx}} \left(\frac{\text{DATAx}}{2^{(12+\text{OUTPUT}_{GAIN})}} + \frac{\text{CHx}_{OFFSET}}{2^{16}} \right)$$

where

- DATAx = Conversion result from the DATA_CHx register
- CHx_OFFSET = Offset value set in the OFFSET_CHx register
- OUTPUT_GAIN = output multiplication factor set in the RESET_DEVICE.OUTPUT_GAIN register (8)

8.3.3 Current Drive Control Registers

The registers listed in Table 9 are used to control the sensor drive current. The recommendations listed in the last column of Table 9 should be followed.

Auto-calibration mode is used to determine the optimal sensor drive current for a fixed sensor design. This mode should only be used during system prototyping.

The auto-amplitude correction attempts to maintain the sensor oscillation amplitude between 1.2V and 1.8V by adjusting the sensor drive current between conversions. When auto-amplitude correction is enabled, the output data may show non-monotonic behavior due to an adjustment in drive current. Auto-amplitude correction is only recommended for low-precision applications.

A high sensor current drive mode can be enabled to drive sensor coils with > 1.5mA on channel 0, only in single channel mode. This feature can be used when the sensor R_P is lower than $1k\Omega$. Set the HIGH_CURRENT_DRV register bit to b1 to enable this mode.

| CHANNEL ⁽¹⁾ | REGISTER | FIELD [BIT(S)] | VALUE |
|------------------------|------------------------------|--------------------------|---|
| | CONFIG, addr 0x1A | SENSOR_ACTIVATE_SEL [11] | Sets current drive for sensor activation. Recommended value is b0 (Full Current mode). |
| All | | RP_OVERRIDE_EN [12] | Set to b1 for normal operation (RP over ride enabled) |
| | | AUTO_AMP_DIS [10] | Disables Automatic amplitude correction. Set to b1 for normal operation (disabled) |
| 0 | CONFIG, addr 0x1A | HIGH_CURRENT_DRV [6] | b0 = normal current drive (1.5 mA) b1 = Increased current drive (> 1.5 mA) for Ch 0 in single channel mode only. Cannot be used in multi-channel mode. |
| 0 | DRIVE_CURRENT_CH0, addr 0x1E | CH0_IDRIVE [15:11] | Drive current used during the settling and conversion time for Ch. 0 (auto-amplitude correction must be disabled and RP over ride=1) |
| | | CH0_INIT_IDRIVE [10:6] | Initial drive current stored during auto- calibration. Not used for normal operation. |
| 1 | DRIVE_CURRENT_CH1, addr 0x1F | CH1_IDRIVE [15:11] | Drive current used during the settling and conversion time for Ch. 1 (auto-amplitude correction must be disabled and RP over ride=1) |
| | | CH1_INIT_IDRIVE [10:6] | Initial drive current stored during auto- calibration. Not used for normal operation. |
| 2 | DRIVE_CURRENT_CH2, addr 0x20 | CH2_IDRIVE [15:11] | Drive current used during the settling and conversion time for Ch. 2 (auto-amplitude correction must be disabled and RP over ride=1) |
| | | CH2_INIT_IDRIVE [10:6] | Initial drive current stored during auto- calibration. Not used for normal operation. |

Table 9. Current Drive Control Registers

⁽¹⁾ Channels 2 and 3 are available for LDC1314 only.



| CHANNEL ⁽¹⁾ | REGISTER | FIELD [BIT(S)] | VALUE |
|------------------------|------------------------------|------------------------|---|
| 3 | DRIVE_CURRENT_CH3, addr 0x21 | CH3_IDRIVE [15:11] | Drive current used during the settling and conversion time for Ch. 3 (auto-amplitude correction must be disabled and RP over ride=1) |
| | | CH3_INIT_IDRIVE [10:6] | Initial drive current stored during auto- calibration. Not used for normal operation. |

If the R_P value of the sensor attached to channel x is known, Table 10 can be used to select the 5-bit value to be programmed into the CHx_IDRIVE field for the channel. If the measured R_P (at maximum spacing between the sensor and the target) falls between two of the table values, use the current drive value associated with the lower R_P from Table 10. All channels that use an identical sensor/target configuration should use the same IDRIVE value.

| Table 10. CHx | _IDRIVE Values | s for Maximum | Measured R _P . |
|---------------|----------------|---------------|---------------------------|
|---------------|----------------|---------------|---------------------------|

| MEASURED R_P (k Ω) | CHx_IDRIVE REGISTER FIELD VALUE, BINARY (BITS [15:11]) | NOMINAL CURRENT (µA) |
|------------------------------|--|----------------------|
| 90.0 | b00000 | 16 |
| 77.6 | b00001 | 18 |
| 66.9 | b00010 | 20 |
| 57.6 | b00011 | 23 |
| 49.7 | b00100 | 28 |
| 42.8 | b00101 | 32 |
| 36.9 | b00110 | 40 |
| 31.8 | b00111 | 46 |
| 27.4 | b01000 | 52 |
| 23.3 | b01001 | 59 |
| 20.4 | b01010 | 72 |
| 17.6 | b01011 | 82 |
| 15.1 | b01100 | 95 |
| 13.0 | b01101 | 110 |
| 11.2 | b01110 | 127 |
| 9.7 | b01111 | 146 |
| 8.4 | b10000 | 169 |
| 7.2 | b10001 | 195 |
| 6.2 | b10010 | 212 |
| 5.4 | b10011 | 244 |
| 4.6 | b10100 | 297 |
| 4.0 | b10101 | 342 |
| 3.4 | b10110 | 424 |
| 3.0 | b10111 | 489 |
| 2.5 | b11000 | 551 |
| 2.2 | b11001 | 635 |
| 1.9 | b11010 | 763 |
| 1.6 | b11011 | 880 |
| 1.4 | b11100 | 1017 |
| 1.2 | b11101 | 1173 |
| 1.0 | b11110 | 1355 |
| 0.9 | b11111 | 1563 |



If the R_P is not known, the following steps for auto-calibration can be used to configure the needed drive current, either during system prototyping, or during normal startup if feasible:

- 1. Set target at the maximum planned operating distance from the sensor.
- 2. Place the device into SLEEP mode by setting CONFIG.SLEEP_MODE_EN to b0.
- 3. Program the desired values of SETTLECOUNT and RCOUNT values for the channel.
- 4. Enable auto-calibration by setting RP_OVERDRIVE_EN to b0.
- 5. Take the device out of SLEEP mode by setting CONFIG.SLEEP_MODE_EN to b1.
- 6. Allow the device to perform at least one measurement, with the target stable (fixed) at the maximum operating range.
- 7. Read the channel current drive value from the appropriate DRIVE_CURRENT_CHx register (addresses 0x1e, 0x1f, 0x20, or 0x21), in the CHx_INIT_DRIVE field (bits 10:6). Save this value.
- 8. During startup for normal operating mode, write the value saved from the CHx_INIT_DRIVE bit field into the Chx_IDRIVE bit field (bits 15:11).
- 9. During normal operating mode, the RP_OVERRIDE_EN must set to b1 to force the fixed current drive.

If the current drive results in the oscillation amplitude greater than 1.8V, the internal ESD clamping circuit will become active. This may cause the sensor frequency to shift so that the output values no longer represent a valid system state. If the current drive is set at a lower value, the SNR performance of the system will decrease, and at near zero target range, oscillations may completely stop, and the output sample values will be all zeroes.



8.3.4 Device Status Registers

The registers listed in Table 11 may be used to read device status.

| Table | 11. | Status | Registers |
|-------|-----|--------|-----------|
|-------|-----|--------|-----------|

| CHANNEL ⁽¹⁾ | REGISTER | FIELDS [BIT(S)] | VALUES |
|------------------------|-------------------------|--|--|
| All | STATUS, addr 0x18 | 12 fields are available that contain various status bits [15:0] | Refer to Register Maps section for a description of the individual status bits. |
| All | ERROR_CONFIG, addr 0x19 | 12 fields are available that are used to configure error reporting [15:0] | Refer to Register Maps section for a description of the individual error configuration bits. |

(1) Channels 2 and 3 are available for LDC1314 only.

See the STATUS and ERROR_CONFIG register description in the Register Map section. These registers can be configured to trigger an interrupt on the INTB pin for certain events. The following conditions must be met:

- 1. The error or status register must be unmasked by enabling the appropriate register bit in the ERROR_CONFIG register
- 2. The INTB function must be enabled by setting CONFIG.INTB_DIS to 0

When a bit field in the STATUS register is set, the entire STATUS register content is held until read or until the DATA_CHx register is read. Reading also de-asserts INTB.

Interrupts are cleared by one of the following events:

- 1. Entering Sleep Mode
- 2. Power-on reset (POR)
- 3. Device enters Shutdown Mode (SD is asserted)
- 4. S/W reset
- 5. I2C read of the STATUS register: Reading the STATUS register will clear any error status bit set in STATUS along with the ERR_CHAN field and de-assert INTB

Setting register CONFIG.INTB_DIS to b1 disables the INTB function and holds the INTB pin high.

8.3.5 Input Deglitch Filter

The input deglitch filter suppresses EMI and ringing above the sensor frequency. It does not impact the conversion result as long as its bandwidth is configured to be above the maximum sensor frequency. The input deglitch filter can be configured in MUX_CONFIG.DEGLITCH register field as shown in Table 12. For optimal performance, TI recommends to select the lowest setting that exceeds the sensor oscillation frequency. For example, if the maximum sensor frequency is 2.0 MHz, choose MUX_CONFIG.DEGLITCH = b100 (3.3 MHz).

| CHANNEL ⁽¹⁾ | MUX_CONFIG.DEGLITCH REGISTER VALUE | DEGLITCH FREQEUNCY |
|------------------------|------------------------------------|--------------------|
| ALL | 001 | 1 MHz |
| ALL | 100 | 3.3 MHz |
| ALL | 101 | 10 MHz |
| ALL | 011 | 33 MHz |

Table 12. Input deglitch filter register

(1) Channels 2 and 3 are available for LDC1314 only.



8.4 Device Functional Modes

8.4.1 Startup Mode

When the LDC powers up, it enters into Sleep Mode and will wait for configuration. Once the device is configured, exit Sleep Mode by setting CONFIG.SLEEP_MODE_EN to b0.

TI recommends to configure the LDC while in Sleep Mode. If a setting on the LDC needs to be changed, return the device to Sleep Mode, change the appropriate register, and then exit Sleep Mode.

8.4.2 Normal (Conversion) Mode

When operating in the normal (conversion) mode, the LDC is periodically sampling the frequency of the sensor(s) and generating sample outputs for the active channel(s).

8.4.3 Sleep Mode

Sleep Mode is entered by setting the CONFIG.SLEEP_MODE_EN register field to 1. While in this mode, the device configuration is maintained. To exit Sleep Mode, set the CONFIG.SLEEP_MODE_EN register field to 0. After setting CONFIG.SLEEP_MODE_EN to b0, sensor activation for the first conversion will begin after 16,384 f_{INT} clock cycles. While in Sleep Mode the I2C interface is functional so that register reads and writes can be performed. While in Sleep Mode, no conversions are performed. In addition, entering Sleep Mode will clear conversion results, any error condition and de-assert the INTB pin.

8.4.4 Shutdown Mode

When the SD pin is set to high, the LDC will enter Shutdown Mode. Shutdown Mode is the lowest power state. To exit Shutdown Mode, set the SD pin to low. Entering Shutdown Mode will return all registers to their default state.

While in Shutdown Mode, no conversions are performed. In addition, entering Shutdown Mode will clear any error condition and de-assert the INTB pin. While the device is in Shutdown Mode, is not possible to read to or write from the device via the I2C interface.

8.4.4.1 Reset

The LDC can be reset by writing to RESET_DEV.RESET_DEV. Any active conversion will stop and all register values will return to their default value. This register bit will always return 0b when read.

8.5 Programming

The LDC device uses an I2C interface to access control and data registers.

8.5.1 I2C Interface Specifications

The LDC uses an extended start sequence with I2C for register access. The maximum speed of the I2C interface is 400kbit/s. This sequence follows the standard I2C 7bit slave address followed by an 8bit pointer register byte to set the register address. When the ADDR pin is set low, the LDC I2C address is 0x2A; when the ADDR pin is set high, the LDC I2C address is 0x2B. The ADDR pin must not change state after the LDC exits Shutdown Mode.



Programming (continued)

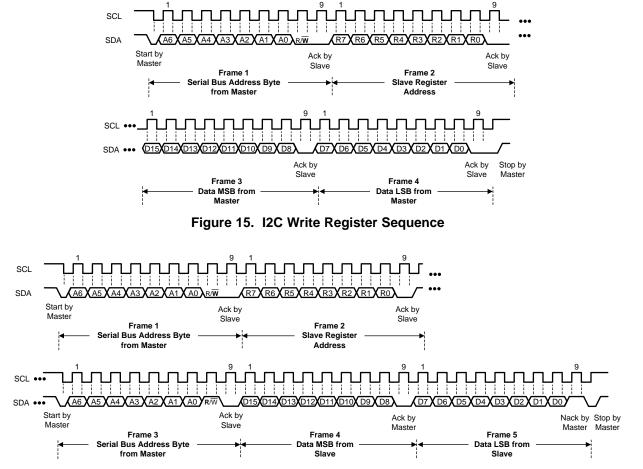


Figure 16. I2C Read Register Sequence



8.6 Register Maps

8.6.1 Register List

Fields indicated with Reserved must be written only with indicated values, otherwise improper device operation may occur. The R/W column indicates the Read-Write status of the corresponding field. A 'R/W' entry indicates read and write capability, a 'R' indicates read-only, and a 'W' indicates write-only.

| ADDRESS | NAME | DEFAULT VALUE | DESCRIPTION |
|---------|------------------------|---------------|--|
| 0x00 | DATA_CH0 | 0x0000 | Channel 0 Conversion Result and Error Status |
| 0x02 | DATA_CH1 | 0x0000 | Channel 1 Conversion Result and Error Status |
| 0x04 | DATA_CH2 | 0x0000 | Channel 2 Conversion Result and Error Status (LDC1314 only) |
| 0x06 | DATA_CH3 | 0x0000 | Channel 3 Conversion Result and Error Status (LDC1314 only) |
| 0x08 | RCOUNT_CH0 | 0x0080 | Reference Count setting for Channel 0 |
| 0x09 | RCOUNT_CH1 | 0x0080 | Reference Count setting for Channel 1 |
| 0x0A | RCOUNT_CH2 | 0x0080 | Reference Count setting for Channel 2. (LDC1314 only) |
| 0x0B | RCOUNT_CH3 | 0x0080 | Reference Count setting for Channel 3.(LDC1314 only) |
| 0x0C | OFFSET_CH0 | 0x0000 | Offset value for Channel 0 |
| 0x0D | OFFSET_CH1 | 0x0000 | Offset value for Channel 1 |
| 0x0E | OFFSET_CH2 | 0x0000 | Offset value for Channel 2 (LDC1314 only) |
| 0x0F | OFFSET_CH3 | 0x0000 | Offset value for Channel 3 (LDC1314 only) |
| 0x10 | SETTLECOUNT_CH0 | 0x0000 | Channel 0 Settling Reference Count |
| 0x11 | SETTLECOUNT_CH1 | 0x0000 | Channel 1 Settling Reference Count |
| 0x12 | SETTLECOUNT_CH2 | 0x0000 | Channel 2 Settling Reference Count (LDC1314 only) |
| 0x13 | SETTLECOUNT_CH3 | 0x0000 | Channel 3 Settling Reference Count (LDC1314 only) |
| 0x14 | CLOCK_DIVIDERS_C H0 | 0x0000 | Reference and Sensor Divider settings for Channel 0 |
| 0x15 | CLOCK_DIVIDERS_C H1 | 0x0000 | Reference and Sensor Divider settings for Channel 1 |
| 0x16 | CLOCK_DIVIDERS_C H2 | 0x0000 | Reference and Sensor Divider settings for Channel 2 (LDC1314 only) |
| 0x17 | CLOCK_DIVIDERS_C H3 | 0x0000 | Reference and Sensor Divider settings for Channel 3 (LDC1314 only) |
| 0x18 | STATUS | 0x0000 | Device Status Report |
| 0x19 | ERROR_CONFIG | 0x0000 | Error Reporting Configuration |
| 0x1A | CONFIG | 0x2801 | Conversion Configuration |
| 0x1B | MUX_CONFIG | 0x020F | Channel Multiplexing Configuration |
| 0x1C | RESET_DEV | 0x0000 | Reset Device |
| 0x1E | DRIVE_CURRENT_CH 0 | 0x0000 | Channel 0 sensor current drive configuration |
| 0x1F | DRIVE_CURRENT_CH | 0x0000 | Channel 1 sensor current drive configuration |
| 0x20 | DRIVE_CURRENT_CH 2 | 0x0000 | Channel 2 sensor current drive configuration (LDC1314 only) |
| 0x21 | DRIVE_CURRENT_CH | 0x0000 | Channel 3 sensor current drive configuration (LDC1314 only) |
| 0x7E | MANUFACTURER_ID | 0x5449 | Manufacturer ID |
| 0x7F | DEVICE_ID | 0x3054 | Device ID |

Figure 17. Register List



8.6.2 Address 0x00, DATA_CH0

Figure 18. Address 0x00, DATA_CH0

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-------------|------------|------------|------------|----|-------|--------|---|
| CH0_ERR_UR | CH0_ERR_OR | CH0_ERR_WD | CH0_ERR_AE | | DATAO | [11:0] | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| DATA0[11:0] | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 13. Address 0x00, DATA_CH0 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------------|------|-------------------|---|
| 15 | CH0_ERR_UR | R | 0 | Channel 0 Conversion Under-range Error Flag. Cleared by reading the bit. |
| 14 | CH0_ERR_OR | R | 0 | Channel 0 Conversion Over-range Error Flag. Cleared by reading the bit. |
| 13 | CH0_ERR_WD | R | 0 | Channel 0 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 12 | CH0_ERR_AE | R | 0 | Channel 0 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 11:0 | DATA0[11:0] | R | 0000 0000 0000 | Channel 0 Conversion Result |

8.6.3 Address 0x02, DATA_CH1

Figure 19. Address 0x02, DATA_CH1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-------------|------------|------------|------------|----|-------|--------|---|
| CH1_ERR_UR | CH1_ERR_OR | CH1_ERR_WD | CH1_ERR_AE | | DATA1 | [11:0] | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| DATA1[11:0] | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 14. Address 0x02, DATA_CH1 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------------|------|-------------------|---|
| 15 | CH1_ERR_UR | R | 0 | Channel 1 Conversion Under-range Error Flag. Cleared by reading the bit. |
| 14 | CH1_ERR_OR | R | 0 | Channel 1 Conversion Over-range Error Flag. Cleared by reading the bit. |
| 13 | CH1_ERR_WD | R | 0 | Channel 1 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 12 | CH1_ERR_AE | R | 0 | Channel 1 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 11:0 | DATA1[11:0] | R | 0000 0000 0000 | Channel 1 Conversion Result |

Figure 20. Address 0x04, DATA_CH2

| | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | | | | | | | | |
|---|------------|------------|------------|------------|---------|-------|-------------|---|--|--|--|--|--|--|--|--|
| | CH2_ERR_UR | CH2_ERR_OR | CH2_ERR_WD | CH2_ERR_AE | | DATA2 | [11:0] | | | | | | | | | |
| | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | | | | | | | | |
| | | | | | | | | | | | | | | | | |
| L | | | | DATA | 2[11.0] | | DATA2[11:0] | | | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 15. Address 0x04, DATA_CH2 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------------|------|-------------------|---|
| 15 | CH2_ERR_UR | R | 0 | Channel 2 Conversion Under-range Error Flag. Cleared by reading the bit. |
| 14 | CH2_ERR_OR | R | 0 | Channel 2 Conversion Over-range Error Flag. Cleared by reading the bit. |
| 13 | CH2_ERR_WD | R | 0 | Channel 2 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 12 | CH2_ERR_AE | R | 0 | Channel 2 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 11:0 | DATA2[11:0] | R | 0000 0000 0000 | Channel 2 Conversion Result |

8.6.5 Address 0x06, DATA_CH3 (LDC1314 only)

Figure 21. Address 0x06, DATA_CH3

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | | |
|------------|-------------|------------|------------|----|-------|--------|---|--|--|
| CH3_ERR_UR | CH3_ERR_OR | CH3_ERR_WD | CH3_ERR_AE | | DATA3 | [11:0] | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | | |
| | DATA3[11:0] | | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 16. Address 0x06, DATA_CH3 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-------------|------|-------------------|---|
| 15 | CH3_ERR_UR | R | 0 | Channel 3 Conversion Under-range Error Flag. Cleared by reading the bit. |
| 14 | CH3_ERR_OR | R | 0 | Channel 3 Conversion Over-range Error Flag. Cleared by reading the bit. |
| 13 | CH3_ERR_WD | R | 0 | Channel 3 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 12 | CH3_ERR_AE | R | 0 | Channel 3 Conversion Watchdog Timeout Error Flag. Cleared by reading the bit. |
| 11:0 | DATA3[11:0] | R | 0000 0000 0000 | Channel 3 Conversion Result |

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8.6.6 Address 0x08, RCOUNT_CH0

Figure 22. Address 0x08, RCOUNT_CH0

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | |
|----|------------|----|----|----|----|---|---|--|
| | CH0_RCOUNT | | | | | | | |
| | | | | | | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| | CH0_RCOUNT | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 17. Address 0x08, RCOUNT_CH0 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|---|
| 15:0 | CH0_RCOUNT | R/W | 0000 0000 1000 0000 | Channel 0 Reference Count Conversion Interval Time 0x0000-0x0004: Reserved 0x0005-0xFFFF: Conversion Time $(t_{C0}) =$ (CH0_RCOUNT×16)/f _{REF0} |

8.6.7 Address 0x09, RCOUNT_CH1

Figure 23. Address 0x09, RCOUNT_CH1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | | |
|------------|------------|----|----|----|----|---|---|--|--|
| CH1_RCOUNT | | | | | | | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | | |
| | CH1_RCOUNT | | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 18. Address 0x09, RCOUNT_CH1 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|--|
| 15:0 | CH1_RCOUNT | R/W | 0000 0000 1000 0000 | Channel 1 Reference Count Conversion Interval Time 0x0000-0x0004: Reserved 0x0005-0xFFFF: Conversion Time (t _{C1})= (CH1_RCOUNT×16)/f _{REF1} |

8.6.8 Address 0x0A, RCOUNT_CH2 (LDC1314 only)

Figure 24. Address 0x0A, RCOUNT_CH2

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|------------|----|----|----|----|----|---|---|
| CH2_RCOUNT | | | | | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CH2_RCOUNT | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 19. Address 0x0A, RCOUNT_CH2 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|---|
| 15:0 | CH2_RCOUNT | R/W | 0000 0000 1000 0000 | Channel 2 Reference Count Conversion Interval Time 0x0000-0x0004: Reserved 0x0005-0xFFFF: Conversion Time (t_{C2})= (CH2_RCOUNT×16)/f _{REF2} |

8.6.9 Address 0x0B, RCOUNT_CH3 (LDC1314 only)

Figure 25. Address 0x0B, RCOUNT_CH3

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | | |
|------------|---------------|----|----|----|----|---|---|--|--|
| CH3_RCOUNT | | | | | | | | | |
| 7 | 6 5 4 3 2 1 0 | | | | | | | | |
| | CH3_RCOUNT | | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 20. Address 0x0B, RCOUNT_CH3 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|--|
| 15:0 | CH3_RCOUNT | R/W | 0000 0000 1000 0000 | Channel 3 Reference Count Conversion Interval Time 0x0000-0x0004: Reserved 0x0005-0xFFFF: Conversion Time (t _{C3})= (CH3_RCOUNT×16)/f _{REF3} |

8.6.10 Address 0x0C, OFFSET_CH0

Figure 26. Address 0x0C, CH0_OFFSET

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|----|----|-------|-------|----|---|---|
| | | | CH0_O | FFSET | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | | CH0_O | FFSET | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 21. CH0_OFFSET Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|--|
| 15:0 | CH0_OFFSET | R/W | 0000 0000 0000 0000 | Channel 0 Conversion Offset. $f_{OFFSET_0} = (CH0_OFFSET/2^{16})*f_{REF0}$ |

8.6.11 Address 0x0D, OFFSET_CH1

Figure 27. Address 0x0D, OFFSET_CH1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | |
|----|----|------------|-------|-------|----|---|---|--|
| | | | CH1_O | FFSET | | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| | | CH1_OFFSET | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 22. Address 0x0D, OFFSET_CH1 Field Descriptions

| | Bit | Field | Туре | Reset | Description |
|---|------|------------|------|------------------------|--|
| 1 | 15:0 | CH1_OFFSET | R/W | 0000 0000 0000 0000 | Channel 1 Conversion Offset. f _{OFFSET_1} = (CH1_OFFSET/2 ¹⁶)*f _{REF1} |

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8.6.12 Address 0x0E, OFFSET_CH2 (LDC1314 only)

Figure 28. Address 0x0E, OFFSET_CH2

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|----|----|-------|-------|----|---|---|
| | | | CH2_O | FFSET | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | | CH2_O | FFSET | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 23. Address 0x0E, OFFSET_CH2 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|---|
| 15:0 | CH2_OFFSET | R/W | 0000 0000 0000 0000 | Channel 2 Conversion Offset. f _{OFFSET_2} = (CH2_OFFSET/2 ¹⁶)*f _{REF2} |

8.6.13 Address 0x0F, OFFSET_CH3 (LDC1314 only)

Figure 29. Address 0x0F, OFFSET_CH3

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|------------|----|-------|-------|----|---|---|
| | | | CH3_O | FFSET | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | CH3_OFFSET | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 24. Address 0x0F, OFFSET_CH3 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|------------|------|------------------------|--|
| 15:0 | CH3_OFFSET | R/W | 0000 0000 0000 0000 | Channel 3 Conversion Offset. f _{OFFSET_3} = (CH3_OFFSET/2 ¹⁶)*f _{REF3} |

8.6.14 Address 0x10, SETTLECOUNT_CH0

Figure 30. Address 0x10, SETTLECOUNT_CH0

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|----|----|----------|-----------------|----|---|---|
| | | | CH0_SET1 | ILECOUNT | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | | CH0_SET1 | LECOUNT | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 25. Address 0x11, SETTLECOUNT_CH0 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------------|------|-------|---|
| 15:0 | CH0_SETTLECOUNT | R/W | | Channel 0 Conversion Settling The LDC will use this settling time to allow the LC sensor to stabilize before initiation of a conversion on Channel 0. If the amplitude has not settled prior to the conversion start, an Amplitude error will be generated if reporting of this type of error is enabled. 0x0000: Settle Time (t_{S0})= 32 ÷ f _{REF0} 0x0001: Settle Time (t_{S0})= 32 ÷ f _{REF0} 0x0002- 0xFFFF: Settle Time (t_{S0})= (CH0_SETTLECOUNT×16) ÷ f _{REF0} |

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8.6.15 Address 0x11, SETTLECOUNT_CH1

Figure 31. Address 0x11, SETTLECOUNT_CH1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|----|----|----------|----------|----|---|---|
| | | | CH1_SET1 | TLECOUNT | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| - | | - | CH1_SETT | TLECOUNT | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 26. Address 0x12, SETTLECOUNT_CH1 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------------|------|-----------|-------------|
| 15:0 | CH1_SETTLECOUNT | R/W | 0000 0000 | |

8.6.16 Address 0x12, SETTLECOUNT_CH2 (LDC1314 only)

Figure 32. Address 0x12, SETTLECOUNT_CH2

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-----------------|----|----|----------|---------|----|---|---|
| | | | CH2_SETT | LECOUNT | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CH2_SETTLECOUNT | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 27. Address 0x12, SETTLECOUNT_CH2 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------------|------|-----------|--|
| 15:0 | CH2_SETTLECOUNT | R/W | 0000 0000 | Channel 2 Conversion Settling The LDC will use this settling time to allow the LC sensor to stabilize before initiation of a conversion on Channel 2. If the amplitude has not settled prior to the conversion start, an Amplitude error will be generated if reporting of this type of error is enabled. 0x0000: Settle Time (t_{S2})= 32 ÷ f_{REF2} 0x0001: Settle Time (t_{S2})= 32 ÷ f_{REF2} 0x0002- 0xFFFF: Settle Time (t_{S2})= (CH2_SETTLECOUNT×16) ÷ f_{REF2} |

8.6.17 Address 0x13, SETTLECOUNT_CH3 (LDC1314 only)

Figure 33. Address 0x13, SETTLECOUNT_CH3

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-----------------|----|----|----------|---------|----|---|---|
| | | | CH3_SET1 | LECOUNT | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CH3_SETTLECOUNT | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 28. Address 0x13, SETTLECOUNT_CH3 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------------|------|-----------|-------------|
| 15:0 | CH3_SETTLECOUNT | R/W | 0000 0000 | |

8.6.18 Address 0x14, CLOCK_DIVIDERS_CH0

Figure 34. Address 0x14, CLOCK_DIVIDERS_CH0

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|------------------|----|----|----|------|----------|-----------|
| | CH0_FIN_DIVIDER | | | | RVED | CH0_FREI | F_DIVIDER |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | CH0_FREF_DIVIDER | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 29. Address 0x14, CLOCK_DIVIDERS_CH0 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|------------------|------|-----------------|---|
| 15:12 | CH0_FIN_DIVIDER | R/W | 0000 | Channel 0 Input Divider Sets the divider for Channel 0 input. Must be set to ≥ 2 if the Sensor frequency is ≥ 8.75 MHz b0000: Reserved. Do not use. CH0_FIN_DIVIDER \geq b0001: f _{in0} = f _{SENSOR0} /CH0_FIN_DIVIDER |
| 11:10 | RESERVED | R/W | 00 | Reserved. Set to b00. |
| 9:0 | CH0_FREF_DIVIDER | R/W | 00 0000 0000 | Channel 0 Reference Divider Sets the divider for Channel 0 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: Reserved. Do not use. CH0_FREF_DIVIDER≥b00'0000'0001: f _{REF0} = f _{CLK} /CH0_FREF_DIVIDER |

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8.6.19 Address 0x15, CLOCK_DIVIDERS_CH1

Figure 35. Address 0x15, CLOCK_DIVIDERS_CH1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | |
|----|------------------|----|----|----|------|----------|-----------|--|
| | CH1_FIN_DIVIDER | | | | RVED | CH1_FREF | F_DIVIDER | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| | CH1_FREF_DIVIDER | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 30. Address 0x15, CLOCK_DIVIDERS_CH1 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|------------------|------|-----------------|---|
| 15:12 | CH1_FIN_DIVIDER | R/W | 0000 | Channel 1 Input Divider. Sets the divider for Channel 1 input. Used when the Sensor frequency is greater than the maximum F _{IN} . b0000: Reserved. Do not use. CH1_FIN_DIVIDER≥b0001: f _{in1} = f _{SENSOR1} /CH1_FIN_DIVIDER |
| 11:10 | RESERVED | R/W | 00 | Reserved. Set to b00. |
| 9:0 | CH1_FREF_DIVIDER | R/W | 00 0000 0000 | Channel 1 Reference Divider. Sets the divider for Channel 1 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: Reserved. Do not use. CH1_FREF_DIVIDER> b00'0000'0001: $f_{REF1} = f_{CLK}/CH1_FREF_DIVIDER$ |

8.6.20 Address 0x16, CLOCK_DIVIDERS_CH2 (LDC1314 only)

Figure 36. Address 0x16, CLOCK_DIVIDERS_CH2

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----|------------------|----------|----|------|------|----------|----------|
| | CH2_FIN | _DIVIDER | | RESE | RVED | CH2_FREF | _DIVIDER |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | CH2_FREF_DIVIDER | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 31. Address 0x16, CLOCK_DIVIDERS_CH2 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|------------------|------|-----------------|---|
| 15:12 | CH2_FIN_DIVIDER | R/W | 0000 | Channel 2 Input Divider. Sets the divider for Channel 2 input. Must be set to ≥ 2 if the Sensor frequency is ≥ 8.75 MHz. b0000: Reserved. Do not use. CH2_FIN_DIVIDER \geq b0001: $f_{IN2} = f_{SENSOR2}$ /CH2_FIN_DIVIDER |
| 11:10 | RESERVED | R/W | 00 | Reserved. Set to b00 |
| 9:0 | CH2_FREF_DIVIDER | R/W | 00 0000 0000 | Channel 2 Reference Divider. Sets the divider for Channel 2 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: Reserved. Do not use. CH2_FREF_DIVIDER \geq b00'0000'0001: f _{REF2} = f _{CLK} /CH2_FREF_DIVIDER |

8.6.21 Address 0x17, CLOCK_DIVIDERS_CH3 (LDC1314 only)

Figure 37. Address 0x17, CLOCK_DIVIDERS_CH3

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | |
|----|------------------|----|----|----|------|----------|----------|--|
| | CH3_FIN_DIVIDER | | | | RVED | CH3_FREF | _DIVIDER | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| | CH3_FREF_DIVIDER | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 32. Address 0x17, CLOCK_DIVIDERS_CH3

| Bit | Field | Туре | Reset | Description |
|-------|------------------|------|-----------------|--|
| 15:12 | CH3_FIN_DIVIDER | R/W | 0000 | Channel 3 Input Divider. Sets the divider for Channel 3 input. Must be set to ≥ 2 if the Sensor frequency is ≥ 8.75 MHz. b0000: Reserved. Do not use. CH3_FIN_DIVIDER \geq b0001: f _{IN3} = f _{SENSOR3} /CH3_FIN_DIVIDER |
| 11:10 | RESERVED | R/W | 00 | Reserved. Set to b00 |
| 9:0 | CH3_FREF_DIVIDER | R/W | 00 0000 0000 | Channel 3 Reference Divider. Sets the divider for Channel 3 reference. Use this to scale the maximum conversion frequency. b00'0000'0000: reserved CH3_FREF_DIVIDER \geq b00'0000'0001: f _{REF3} = f _{CLK} /CH3_FREF_DIVIDER |

8.6.22 Address 0x18, STATUS

Figure 38. Address 0x18, STATUS

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----------|------|----------|--------|--------------------|--------------------|--------------------|--------------------|
| ERR_ | CHAN | ERR_UR | ERR_OR | ERR_WD | ERR_AHE | ERR_ALE | ERR_ZC |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| RESERVED | DRDY | RESERVED | | CH0_UNREA DCONV | CH1_ UNREADCONV | CH2_ UNREADCONV | CH3_ UNREADCONV |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 33. Address 0x18, STATUS Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|----------|------|-------|---|
| 15:14 | ERR_CHAN | R | 00 | Error Channel Indicates which channel has generated a Flag or Error. Once flagged, any reported error is latched and maintained until either the STATUS register or the DATA_CHx register corresponding to the Error Channel is read. b00: Channel 0 is source of flag or error. b01: Channel 1 is source of flag or error. b10: Channel 2 is source of flag or error (LDC1314 only). b11: Channel 3 is source of flag or error (LDC1314 only). |
| 13 | ERR_UR | R | 0 | Conversion Under-range Error b0: No Conversion Under-range error was recorded since the last read of the STATUS register. b1: An active channel has generated a Conversion Under-range error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error. |
| 12 | ERR_OR | R | 0 | Conversion Over-range Error. b0: No Conversion Over-range error was recorded since the last read of the STATUS register. b1: An active channel has generated a Conversion Over-range error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error. |

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| Bit | Field | Туре | Reset | Description |
|-----|-----------------|------|-------|---|
| 11 | ERR_WD | R | 0 | Watchdog Timeout Error b0: No Watchdog Timeout error was recorded since the last read of the STATUS register. b1: An active channel has generated a Watchdog Timeout error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error. |
| 10 | ERR_AHE | R | 0 | Amplitude High Error b0: No Amplitude High error was recorded since the last read of the STATUS register. b1: An active channel has generated an Amplitude High error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error. |
| 9 | ERR_ALE | R | 0 | Amplitude Low Error b0: No Amplitude Low error was recorded since the last read of the STATUS register. b1: An active channel has generated an Amplitude Low error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error. |
| 8 | ERR_ZC | R | 0 | Zero Count Error b0: No Zero Count error was recorded since the last read of the STATUS register. b1: An active channel has generated a Zero Count error. Refer to STATUS.ERR_CHAN field to determine which channel is the source of this error. |
| 6 | DRDY | R | 0 | Data Ready Flag. b0: No new conversion result was recorded in the STATUS register. b1: A new conversion result is ready. When in Single Channel Conversion, this indicates a single conversion is available. When in sequential mode, this indicates that a new conversion result for all active channels is now available. |
| 3 | CH0_UNREADCONV | R | 0 | Channel 0 Unread Conversion b0: No unread conversion is present for Channel 0. b1: An unread conversion is present for Channel 0. Read Register DATA_CH0 to retrieve conversion results. |
| 2 | CH1_UNREADCONV | R | 0 | Channel 1 Unread Conversion b0: No unread conversion is present for Channel 1. b1: An unread conversion is present for Channel 1. Read Register DATA_CH1 to retrieve conversion results. |
| 1 | CH2_ UNREADCONV | R | 0 | Channel 2 Unread Conversion b0: No unread conversion is present for Channel 2. b1: An unread conversion is present for Channel 2. Read Register DATA_CH2 to retrieve conversion results (LDC1314 only) |
| 0 | CH3_ UNREADCONV | R | 0 | Channel 3 Unread Conversion b0: No unread conversion is present for Channel 3. b1: An unread conversion is present for Channel 3. Read Register DATA_CH3 to retrieve conversion results (LDC1314 only) |

Table 33. Address 0x18, STATUS Field Descriptions (continued)

8.6.23 Address 0x19, ERROR_CONFIG

Figure 39. Address 0x19, ERROR_CONFIG

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|------------|------------|----------------|------------|------------|------------|----------|-----------|
| UR_ERR2OUT | OR_ERR2OUT | WD_ ERR2OUT | AH_ERR2OUT | AL_ERR2OUT | | RESERVED | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| UR_ERR2INT | OR_ERR2INT | WD_ERR2INT | AH_ERR2INT | AL_ERR2INT | ZC_ERR2INT | Reserved | DRDY_2INT |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset



Table 34. Address 0x19, ERROR_CONFIG

| Bit | Field | Туре | Reset | Description |
|-----|-------------|------|-------|---|
| 15 | UR_ERR2OUT | R/W | 0 | Under-range Error to Output Register b0: Do not report Under-range errors in the DATA_CHx registers. b1: Report Under-range errors in the DATA_CHx.CHx_ERR_UR register field corresponding to the channel that generated the error. |
| 14 | OR_ERR2OUT | R/W | 0 | Over-range Error to Output Register b0: Do not report Over-range errors in the DATA_CHx registers. b1: Report Over-range errors in the DATA_CHx.CHx_ERR_OR register field corresponding to the channel that generated the error. |
| 13 | WD_ ERR2OUT | R/W | 0 | Watchdog Timeout Error to Output Register b0: Do not report Watchdog Timeout errors in the DATA_CHx registers. b1: Report Watchdog Timeout errors in the DATA_CHx.CHx_ERR_WD register field corresponding to the channel that generated the error. |
| 12 | AH_ERR2OUT | R/W | 0 | Amplitude High Error to Output Register b0:Do not report Amplitude High errors in the DATA_CHx registers. b1: Report Amplitude High errors in the DATA_CHx.CHx_ERR_AE register field corresponding to the channel that generated the error. |
| 11 | AL_ERR2OUT | R/W | 0 | Amplitude Low Error to Output Register b0: Do not report Amplitude High errors in the DATA_CHx registers. b1: Report Amplitude High errors in the DATA_CHx.CHx_ERR_AE register field corresponding to the channel that generated the error. |
| 7 | UR_ERR2INT | R/W | 0 | Under-range Error to INTB b0: Do not report Under-range errors by asserting INTB pin and STATUS register. b1: Report Under-range errors by asserting INTB pin and updating STATUS.ERR_UR register field. |
| 6 | OR_ERR2INT | R/W | 0 | Over-range Error to INTB b0: Do not report Over-range errors by asserting INTB pin and STATUS register. b1: Report Over-range errors by asserting INTB pin and updating STATUS.ERR_OR register field. |
| 5 | WD_ERR2INT | R/W | 0 | Watchdog Timeout Error to INTB b0: Do not report Under-range errors by asserting INTB pin and STATUS register. b1: Report Watchdog Timeout errors by asserting INTB pin and updating STATUS.ERR_WD register field. |
| 4 | AH_ERR2INT | R/W | 0 | Amplitude High Error to INTB b0: Do not report Amplitude High errors by asserting INTB pin and STATUS register. b1: Report Amplitude High errors by asserting INTB pin and updating STATUS.ERR_AHE register field. |
| 3 | AL_ERR2INT | R/W | 0 | Amplitude Low Error to INTB b0: Do not report Amplitude Low errors by asserting INTB pin and STATUS register. b1: Report Amplitude Low errors by asserting INTB pin and updating STATUS.ERR_ALE register field. |
| 2 | ZC_ERR2INT | R/W | 0 | Zero Count Error to INTB b0: Do not report Zero Count errors by asserting INTB pin and STATUS register. b1: Report Zero Count errors by asserting INTB pin and updating STATUS. ERR_ZC register field. |
| 1 | Reserved | R/W | 0 | Reserved (set to b0) |
| 0 | DRDY_2INT | R/W | 0 | Data Ready Flag to INTB b0: Do not report Data Ready Flag by asserting INTB pin and STATUS register. b1: Report Data Ready Flag by asserting INTB pin and updating STATUS. DRDY register field. |

8.6.24 Address 0x1A, CONFIG

Figure 40. Address 0x1A, CONFIG

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----------|----------------------|-------------------|--------------------|-------------------------|------------------|-----------------|----------|
| ACTIVE | E_CHAN | SLEEP_MODE _EN | RP_OVERRID E_EN | SENSOR_ACTI VATE_SEL | AUTO_AMP_DI S | REF_CLK_SR C | RESERVED |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| INTB_DIS | HIGH_CURRE NT_DRV | | | RESE | RVED | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 35. Address 0x1A, CONFIG Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|---------------------|------|---------|--|
| 15:14 | ACTIVE_CHAN | R/W | 00 | Active Channel Selection Selects channel for continuous conversions when MUX_CONFIG.SEQUENTIAL is 0. b00: Perform continuous conversions on Channel 0 b01: Perform continuous conversions on Channel 1 b10: Perform continuous conversions on Channel 2 (LDC1314 only) b11: Perform continuous conversions on Channel 3 (LDC1314 only) |
| 13 | SLEEP_MODE_EN | R/W | 1 | Sleep Mode Enable Enter or exit low power Sleep Mode. b0: Device is active. b1: Device is in Sleep Mode. |
| 12 | RP_OVERRIDE_EN | R/W | 0 | Sensor R_P Override Enable Provides control over Sensor current drive used during the conversion time for Ch. x, based on the programmed value in the CHx_IDRIVE field. b0: Override off b1: R_P Override on |
| 11 | SENSOR_ACTIVATE_SEL | R/W | 1 | Sensor Activation Mode Selection. Set the mode for sensor initialization. b0: Full Current Activation Mode – the LDC will drive maximum sensor current for a shorter sensor activation time. b1: Low Power Activation Mode – the LDC uses the value programmed in DRIVE_CURRENT_CHx during sensor activation to minimize power consumption. |
| 10 | AUTO_AMP_DIS | R/W | 0 | Automatic Sensor Amplitude Correction Disable Setting this bit will disable the automatic Amplitude correction algorithm and stop the updating of the CHx_INIT_IDRIVE field. b0: Automatic Amplitude correction enabled b1: Automatic Amplitude correction is disabled. Recommended for precision applications. |
| 9 | REF_CLK_SRC | R/W | 0 | Select Reference Frequency Source b0: Use Internal oscillator as reference frequency b1: Reference frequency is provided from CLKIN pin. |
| 8 | RESERVED | R/W | 0 | Reserved. Set to b0. |
| 7 | INTB_DIS | R/W | 0 | INTB Disable b0: INTB pin will be asserted when status register updates. b1: INTB pin will not be asserted when status register updates |
| 6 | HIGH_CURRENT_DRV | R/W | 0 | High Current Sensor Drive b0: The LDC will drive all channels with normal sensor current (1.5mA max). b1: The LDC will drive channel 0 with current >1.5mA. This mode is not supported if AUTOSCAN_EN = b1 (multi- channel mode) |
| 5:0 | RESERVED | R/W | 00 0001 | Reserved Set to b00'0001 |



8.6.25 Address 0x1B, MUX_CONFIG

Figure 41. Address 0x1B, MUX_CONFIG

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-----------------|--------|----------|----|----|----------|----------|---|
| AUTOSCAN_E N | RR_SEC | QUENCE | | | RESERVED | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| | | RESERVED | | | | DEGLITCH | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 36. Address 0x1B, MUX_CONFIG Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|-------------|------|-----------------|--|
| 15 | AUTOSCAN_EN | R/W | 0 | Auto-Scan Mode Enable b0: Continuous conversion on the single channel selected by CONFIG.ACTIVE_CHAN register field. b1: Auto-Scan conversions as selected by MUX_CONFIG.RR_SEQUENCE register field. |
| 14:13 | RR_SEQUENCE | R/W | 00 | Auto-Scan Sequence Configuration Configure multiplexing channel sequence. The LDC will perform a single conversion on each channel in the sequence selected, and then restart the sequence continuously. b00: Ch0, Ch1 b01: Ch0, Ch1, Ch2 (LDC1314 only) b10: Ch0, Ch1, Ch2, Ch3 (LDC1314 only) b11: Ch0, Ch1 |
| 12:3 | RESERVED | R/W | 00 0100 0001 | Reserved. Must be set to 00 0100 0001 |
| 2:0 | DEGLITCH | R/W | 111 | Input deglitch filter bandwidth. Select the lowest setting that exceeds the oscillation tank oscillation frequency. b001: 1MHz b100: 3.3MHz b101: 10MHz b111: 33MHz |

8.6.26 Address 0x1C, RESET_DEV

Figure 42. Address 0x1C, RESET_DEV

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|--------------------|-----------------|----|----|--------|-------|----------|---|
| RESET_DEV RESERVED | | | | OUTPUT | _GAIN | RESERVED | |
| 7 | 7 6 5 4 3 2 1 0 | | | | | | 0 |
| | RESERVED | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 37. Address 0x1C, RESET_DEV Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|-------------|------|----------------|--|
| 15 | RESET_DEV | R/W | 0 | Device Reset Write b1 to reset the device. Will always readback 0. |
| 14:11 | RESERVED | R/W | 0000 | Reserved. Set to b0000 |
| 10:9 | OUTPUT_GAIN | R/W | 00 | Output gain control 00: Gain = 1 (0 bits shift) 01: Gain = 4 (2 bits shift) 10: Gain = 8 (3 bits shift) 11: Gain = 16 (4 bits shift) |
| 8:0 | RESERVED | R/W | 0 0000 0000 | Reserved, Set to b0 0000 0000 |

8.6.27 Address 0x1E, DRIVE_CURRENT_CH0

Figure 43. Address 0x1E, DRIVE_CURRENT_CH0

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|------------|----------|----|----|------|------|----------------|---|
| CH0_IDRIVE | | | | | | CH0_INIT_IDRIV | E |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CH0_INI | T_IDRIVE | | | RESE | RVED | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 38. Address 0x1E, DRIVE_CURRENT_CH0 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|-----------------|------|---------|---|
| 15:11 | CH0_IDRIVE | R/W | 0 0000 | Channel 0 L-C Sensor drive current This field defines the Drive Current used during the settling + conversion time of Channel 0 sensor clock. RP_OVERRIDE_EN bit must be set to 1. |
| 10:6 | CH0_INIT_IDRIVE | R | 0 0000 | Channel 0 Sensor Current Drive This field stores the Initial Drive Current calculated during the initial Amplitude Calibration phase. It is updated after each Amplitude Correction phase of the sensor clock if the AUTO_AMP_DIS field is NOT set. |
| 5:0 | RESERVED | - | 00 0000 | Reserved |

8.6.28 Address 0x1F, DRIVE_CURRENT_CH1

Figure 44. Address 0x1F, DRIVE_CURRENT_CH1

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|---------|----------|------------|----|-----------------|----|---|---|
| | | CH1_IDRIVE | | CH1_INIT_IDRIVE | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CH1_INI | T_IDRIVE | RESERVED | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 39. Address 0x1F, DRIVE_CURRENT_CH1 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|-----------------|------|---------|---|
| 15:11 | CH1_IDRIVE | R/W | 0 0000 | Channel 1 L-C Sensor drive current This field defines the Drive Current used during the settling + conversion time of Channel 1 sensor clock. RP_OVERRIDE_EN bit must be set to 1. |
| 10:6 | CH1_INIT_IDRIVE | R | 0 0000 | Channel 1 Sensor Current Drive This field stores the Initial Drive Current calculated during the initial Amplitude Calibration phase. It is updated after each Amplitude Correction phase of the sensor clock if the AUTO_AMP_DIS field is NOT set. |
| 5:0 | RESERVED | - | 00 0000 | Reserved |



8.6.29 Address 0x20, DRIVE_CURRENT_CH2 (LDC1314 only)

Figure 45. Address 0x20, DRIVE_CURRENT_CH2

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-----------------|----|------------|----|-----------------|------|---|---|
| | | CH2_IDRIVE | | CH2_INIT_IDRIVE | E | | |
| 7 | 6 | 5 4 3 2 1 | | | | 0 | |
| CH2_INIT_IDRIVE | | | | RESER | RVED | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 40. Address 0x20, DRIVE_CURRENT_CH2 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|-----------------|------|---------|---|
| 15:11 | CH2_IDRIVE | R/W | 0 0000 | Channel 2 L-C Sensor drive current This field defines the Drive Current to be used during the settling + conversion time of Channel 2 sensor clock. RP_OVERRIDE_EN bit must be set to 1. |
| 10:6 | CH2_INIT_IDRIVE | R | 0 0000 | Channel 2 Sensor Current Drive This field stores the Initial Drive Current calculated during the initial Amplitude Calibration phase. It is updated after each Amplitude Correction phase of the sensor clock if the AUTO_AMP_DIS field is NOT set. |
| 5:0 | RESERVED | - | 00 0000 | Reserved |

8.6.30 Address 0x21, DRIVE_CURRENT_CH3 (LDC1314 only)

Figure 46. Address 0x21, DRIVE_CURRENT_CH3

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|----------------------------|----------|----|----|-------|------|---|---|
| CH3_IDRIVE CH3_INIT_IDRIVE | | | | | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| CH3_INI | T_IDRIVE | | | RESEF | RVED | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 41. DRIVE_CURRENT_CH3 Field Descriptions

| Bit | Field | Туре | Reset | Description |
|-------|-----------------|------|---------|---|
| 15:11 | CH3_IDRIVE | R/W | 0 0000 | Channel 3 L-C Sensor drive current This field defines the Drive Current to be used during the settling + conversion time of Channel 3 sensor clock. RP_OVERRIDE_EN bit must be set to 1. |
| 10:6 | CH3_INIT_IDRIVE | R | 0 0000 | Channel 3 Sensor Current Drive This field stores the Initial Drive Current calculated during the initial Amplitude Calibration phase. It is updated after each Amplitude Correction phase of the sensor clock if the AUTO_AMP_DIS field is NOT set. |
| 5:0 | RESERVED | - | 00 0000 | Reserved |

8.6.31 Address 0x7E, MANUFACTURER_ID

Figure 47. Address 0x7E, MANUFACTURER_ID

| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
|-----------------|----|----|----|----|----|---|---|
| MANUFACTURER_ID | | | | | | | |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| MANUFACTURER_ID | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 42. Address 0x7E, MANUFACTURER_ID Field Descriptions

| Bit | Field | Туре | Reset | Description |
|------|-----------------|------|------------------------|--------------------------|
| 15:0 | MANUFACTURER_ID | R | 0101 0100 0100 1001 | Manufacturer ID = 0x5449 |

8.6.32 Address 0x7F, DEVICE_ID

Figure 48. Address 0x7F, DEVICE_ID

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----------|---|---|---|---|---|---|---|
| DEVICE_ID | | | | | | | |

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 43. Address 0x7F, DEVICE_ID Field Descriptions

| Bi | it | Field | Туре | Reset | Description |
|-----|----|-----------|------|------------------------|--------------------|
| 7:0 | 0 | DEVICE_ID | R | 0011 0000 0101 0100 | Device ID = 0x3054 |



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

9.1.1 Theory of Operation

9.1.1.1 Conductive Objects in an EM Field

An AC current flowing through an inductor will generate an AC magnetic field. If a conductive material, such as a metal object, is brought into the vicinity of the inductor, the magnetic field will induce a circulating current (eddy current) on the surface of the conductor.

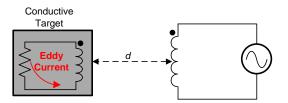


Figure 49. Conductor in AC Magnetic Field

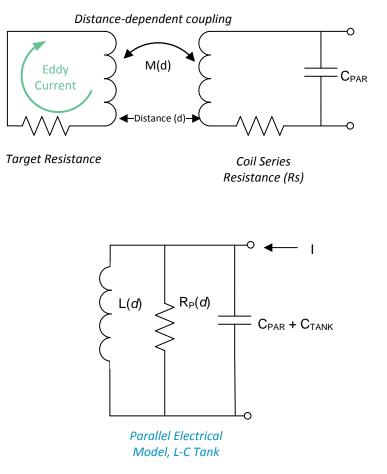
The eddy current is a function of the distance, size, and composition of the conductor. The eddy current generates its own magnetic field, which opposes the original field generated by the sensor inductor. This effect is equivalent to a set of coupled inductors, where the sensor inductor is the primary winding and the eddy current in the target object represents the secondary inductor. The coupling between the inductors is a function of the sensor inductor, and the resistivity, distance, size, and shape of the conductive target. The resistance and inductance of the secondary winding caused by the eddy current can be modeled as a distance dependent resistive and inductive component on the primary side (coil). Figure 49 shows a simplified circuit model of the sensor and the target as coupled coils.

9.1.1.2 L-C Resonators

An EM field can be generated using an L-C resonator, or L-C tank. One topology for an L-C tank is a parallel R-L-C construction, as shown in Figure 50.



Application Information (continued)



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Figure 50. Electrical Model of the L-C Tank Sensor

An oscillator can be constructed by combining a frequency selective circuit (resonator) with a gain block in a closed loop. The criteria for oscillation are: (1) loop gain > 1, and (2) closed loop phase shift of 2π radians. The R-L-C resonator provides the frequency selectivity and contributes to the phase shift. At resonance, the impedance of the reactive components (L and C) cancels, leaving only R_P, the lossy (resistive) element in the circuit. The voltage amplitude is maximized. The R_P can be used to determine the sensor drive current. A lower R_P requires a larger sensor current to maintain a constant oscillation amplitude. The sensor oscillation frequency is given by:

$$f_{\text{SENSOR}} = \frac{1}{2\pi\sqrt{\text{LC}}} * \sqrt{1 - \frac{1}{\text{Q}^2} - \frac{5 * 10^{-9}}{\text{Q}\sqrt{\text{LC}}}} \approx \frac{1}{2\pi\sqrt{\text{LC}}}$$

where

- C is the sensor capacitance (C_{TANK} + C_{PAR})
- L is the inductance
- Q is the quality factor of the resonator. Q can be approximated by:

$$Q = R_P \sqrt{\frac{C}{L}}$$

where

R_s is the AC series resistance of the inductor

(9)

(10)



Application Information (continued)

Texas Instruments' WEBENCH design tool can be used for coil design, in which the parameter values for R_P, L and C are calculated. See http://www.ti.com/webench.

 R_P is a function of target distance, target material, and sensor characteristics. Figure 51 shows that R_P is directly proportional to the distance between the sensor and the target. The graph represents a 14-mm diameter PCB coil (23 turns, 4-mil trace width, 4-mil spacing between traces, 1-oz copper thickness, FR4).

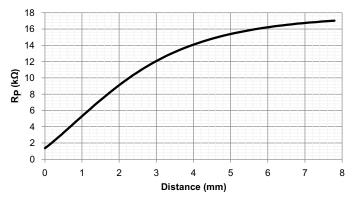


Figure 51. Example RP vs. Distance with a 14-mm PCB Coil and 2mm Thick Stainless Steel Target

It is important to configure the LDC current drive so that the sensor will still oscillate at the minimum R_P value. For example, if the closest target distance in a system with the response shown in Figure 51 is 1mm, then the LDC R_P value is 5 k Ω . The objective is to maintain a sufficient sensor oscillation voltage so that the sensor frequency can be measured even at the minimum operating distance. See section *Current Drive Control Registers* for details on setting the current drive.

The inductance that is measured by the LDC is

$$L(d) = L_{inf} - M(d) = \frac{1}{(2\pi * f_{SENSOR})^2 * C}$$

where

- L(d) is the measured sensor inductance, for a distance d between the sensor coil and target
- L_{inf} is the inductance of the sensing coil without a conductive target (target at infinite distance)
- M(d) is the mutual inductance
- f_{SENSOR} = sensor oscillation frequency for a distance d between the sensor coil and target
- $C = C_{TANK} + C_{PAR}$

(11)

Figure 52 shows an example of variation in sensor frequency and inductance as a function of distance for a 14mm diameter PCB coil (23 turns, 4-mil trace width, 4-mil spacing between traces, 1-oz copper thickness, FR4).



Application Information (continued)

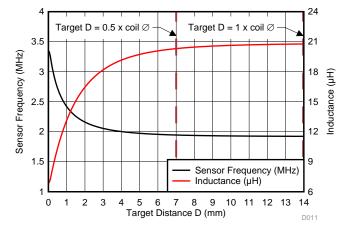


Figure 52. Example Sensor Frequency, Inductance vs. Target Distance with 14-mm PCB Coil and 1.5 mm Thick Aluminum Target

In the absence of magnetic materials, such as ferrous metals and ferrites, the inductance shift, and therefore the measured frequency shift, depends only on current flow geometries. Temperature drift is dominated by physical expansion of the inductor and other mechanical system components over temperature which alter current flow geometries. Note that the additional temperature drift of the sensor capacitor must also be taken into account.

For additional information on temperature effects and temperature compensation, see *LDC1000 Temperature Compensation* (SNAA212)

9.2 Typical Application

Example of a multi-channel implementation using the LDC1312. This example is representative of an axial displacement application, in which the target movement is perpendicular to the plane of the coil. The second channel can be used to sense proximity of a second target, or it can be used for temperature compensation by connecting a reference coil.

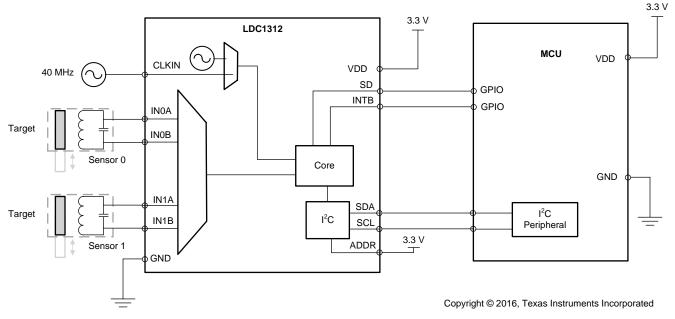


Figure 53. Example Multi-Channel Application - LDC1312



Typical Application (continued)

9.2.1 Design Requirements

- Design example in which Sensor 0 is used for proximity measurement and Sensor 1 is used for temperature compensation:
- Using WEBENCH for coil design
- Target distance = 0.1 cm
- Distance resolution = 0.2 µm
- Target diameter = 1 cm
- Target material = stainless steel (SS416)
- Number of PCB layers for the coil = 2
- The application requires 500SPS ($T_{SAMPLE} = 2000 \ \mu s$)

9.2.2 Detailed Design Procedure

The target distance, resolution and diameter are used as inputs to WEBENCH to design the sensor coil, The resulting coil design is a 2 layer coil, with an area of 2.5 cm², diameter of 1.77 cm, and 39 turns. The values for R_P, L and C are: R_P = 6.6 k Ω , L = 43.9 μ H, C = 100 pF.

Using L and C, $f_{SENSOR} = 1/2\pi \sqrt{(LC)} = 1/2\pi \sqrt{(43.9^{*}10^{-6} * 100^{*}10^{-12})} = 2.4 \text{ MHz}$

Using a system master clock of 40 MHz applied to the CLKIN pin allows flexibility for setting the internal clock frequencies. The sensor coil is connected to channel 0 (INOA and INOB pins).

After powering on the LDC, it will be in Sleep Mode. Program the registers as follows (example sets registers for channel 0 only; channel 1 registers can use equivalent configuration):

- 1. Set the dividers for channel 0.
 - (a) Because the sensor frequency is less than 8.75 MHz, the sensor divider can be set to 1, which means setting field CH0_FIN_DIVIDER to 0x1. By default, $f_{IN0} = f_{SENSOR} = 2.4$ MHz.
 - (b) The design constraint for f_{REF0} is > 4 × f_{SENSOR}. A 20 MHz reference frequency satisfies this constraint, so the reference divider should be set to 2. This is done by setting the CH0_FREF_DIVIDER field to 0x02.
 - (c) The combined value for Chan. 0 divider register (0x14) is 0x1002.
- 2. Program the settling time for Channel 0. The calculated Q of the coil is 10 (see *Multi-Channel and Single Channel Operation*).
 - (a) CH0_SETTLECOUNT \ge Q × f_{REF0} / (16 × f_{SENSOR0}) \rightarrow 5.2, rounded up to 6. To provide margin to account for system tolerances, a higher value of 10 is chosen.
 - (b) Register 0x10 should be programmed to a minimum of 10.
 - (c) The settle time is: $(10 \times 16)/20,000,000 = 8 \ \mu s$
 - (d) The value for Chan. 0 SETTLECOUNT register (0x10) is 0x000A.
- 3. The channel switching delay is ~1µs for f_{REF} = 20 MHz (see *Multi-Channel and Single Channel Operation*)
- 4. Set the conversion time by the programming the reference count for Channel 0. The budget for the conversion time is : T_{SAMPLE} settling time channel switching delay = 1000 8 1 = 991 µs
 - (a) To determine the conversion time register value, use the following equation and solve for CH0_RCOUNT: Conversion Time (t_{C0})= (CH0_RCOUNT×16)/f_{REF0}.
 - (b) This results in CH0_RCOUNT having a value of 1238 decimal (rounded down)
 - (c) Set the CH0_RCOUNT register (0x08) to 0x04D6.
- 5. Use the default values for the ERROR_CONFIG register (address 0x19). By default, no interrupts are enabled
- 6. Sensor drive current: to set the CH0_IDRIVE field value, read the value from Table 10 using $R_P = 6.6 \text{ k}\Omega$. In this case the IDRIVE value should be set to 18 (decimal). The INIT_DRIVE current field should be set to 0x00. The combined value for the DRIVE_CURRENT_CH0 register (addr 0x1E) is 0x9000.
- 7. Program the MUX_CONFIG register
 - (a) Set the AUTOSCAN_EN to b1 bit to enable sequential mode
 - (b) Set RR_SEQUENCE to b00 to enable data conversion on two channels (channel 0, channel 1)
 - (c) Set DEGLITCH to b100 to set the input deglitch filter bandwidth to 3.3MHz, the lowest setting that exceeds the oscillation tank frequency.
 - (d) The combined value for the MUX_CONFIG register (address 0x1B) is 0x820C

Typical Application (continued)

- 8. Finally, program the CONFIG register as follows:
 - (a) Set the ACTIVE_CHAN field to b00 to select channel 0.
 - (b) Set SLEEP_MODE_EN field to b0 to enable conversion.
 - (c) Set RP_OVERRIDE_EN to b1 to disable auto-calibration.
 - (d) Set SENSOR_ACTIVATE_SEL = b0, for full current drive during sensor activation
 - (e) Set the AUTO_AMP_DIS field to b1 to disable auto-amplitude correction
 - (f) Set the REF_CLK_SRC field to b1 to use the external clock source.
 - (g) Set the other fields to their default values.
 - (h) The combined value for the CONFIG register (address 0x1A) is 0x1601.

We then read the conversion results for channel 0 and channel 1 every 1000 μs from register addresses 0x00 and 0x02.

9.2.2.1 Recommended Initial Register Configuration Values

Based on the example configuration in section *Detailed Design Procedure*, the following register write sequence is recommended:

| Address | Value | Register Name | Comments |
|---------|--------|------------------------|---|
| 0x08 | 0x04D6 | RCOUNT_CH0 | Reference count calculated from timing requirements (1 kSPS) and resolution requirements |
| 0x10 | 0x000A | SETTLECOUNT_ CH0 | Minimum settling time for chosen sensor |
| 0x14 | 0x1002 | CLOCK_DIVIDER S_CH0 | CH0_FIN_DIVIDER = 1, CH0_FREF_DIVIDER = 2 |
| 0x19 | 0x0000 | ERROR_CONFIG | Can be changed from default to report status and error conditions |
| 0x1B | 0x020C | MUX_CONFIG | Enable Ch 0 (continuous mode), set Input deglitch bandwidth to 3.3MHz |
| 0x1E | 0x9000 | DRIVE_CURREN T_CH0 | Sets sensor drive current on ch 0 |
| 0x1A | 0x1601 | CONFIG | Select active channel = ch 0, disable auto-amplitude correction and auto- calibration, enable full current drive during sensor activation, select external clock source, wake up device to start conversion. This register write must occur last because device configuration is not permitted while the LDC is in active mode. |

Table 44. Recommended Initial Register Configuration Values (Single-channel Operation)

Table 45. Recommended Initial Register Configuration Values (Multi-channel Operation)

| Address | Value | Register Name | Comments |
|---------|--------|------------------------|--|
| 0x08 | 0x04D6 | RCOUNT_CH0 | Reference count calculated from timing requirements (1 kSPS) and resolution requirements |
| 0x09 | 0x04D6 | RCOUNT_CH1 | Reference count calculated from timing requirements (1 kSPS) and resolution requirements |
| 0x10 | 0x000A | SETTLECOUNT_ CH0 | Minimum settling time for chosen sensor |
| 0x11 | 0x000A | SETTLECOUNT_ CH1 | Minimum settling time for chosen sensor |
| 0x14 | 0x1002 | CLOCK_DIVIDER S_CH0 | CH0_FIN_DIVIDER = 1, CH0_FREF_DIVIDER = 2 |
| 0x15 | 0x1002 | CLOCK_DIVIDER S_CH1 | CH1_FIN_DIVIDER = 1, CH1_FREF_DIVIDER = 2 |
| 0x19 | 0x0000 | ERROR_CONFIG | Can be changed from default to report status and error conditions |
| 0x1B | 0x820C | MUX_CONFIG | Enable Ch 0 and Ch 1 (sequential mode), set Input deglitch bandwidth to 3.3MHz |
| 0x1E | 0x9000 | DRIVE_CURREN T_CH0 | Sets sensor drive current on ch 0 |
| 0x1F | 0x9000 | DRIVE_CURREN T_CH1 | Sets sensor drive current on ch 1 |

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| Table 45. Recommended Initial Register Configuration Values (Multi- | channel Operation) (continued) |
|---|--------------------------------|
| Table 45. Recommended millar Register Comiguation Values (multi- | |

| Address | Value | Register Name | Comments |
|---------|--------|---------------|---|
| 0x1A | 0x1601 | CONFIG | disable auto-amplitude correction and auto-calibration, enable full current drive during sensor activation, select external clock source, wake up device to start conversion. This register write must occur last because device configuration is not permitted while the LDC is in active mode. |

9.2.2.2 Inductor Self-Resonant Frequency

Every inductor has a distributed parasitic capacitance, which is dependent on construction and geometry. At the Self-Resonant Frequency (SRF), the reactance of the inductor cancels the reactance of the parasitic capacitance. Above the SRF, the inductor will electrically appear to be a capacitor. Because the parasitic capacitance is not well-controlled or stable, TI recommends that: $f_{SENSOR} < 0.8 \times f_{SR}$.

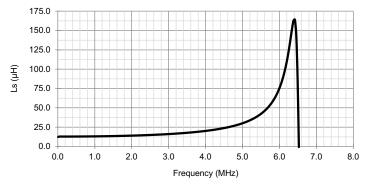


Figure 54. Example Coil Inductance vs. Frequency

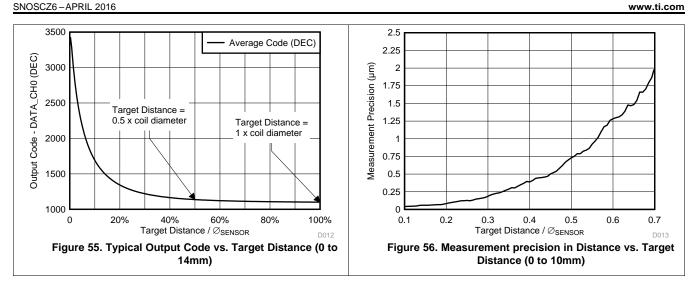
In Figure 54, the inductor has a SRF at 6.38 MHz; therefore the inductor should not be operated above 0.8×6.38 MHz, or 5.1 MHz.

9.2.3 Application Curves

Common test conditions (unless specified otherwise):

- Sensor inductor: 2 layer, 32 turns/layer, 14mm diameter, PCB inductor with L=19.4 µH, R_P=5.7 kΩ at 2 MHz
- Sensor capacitor: 330pF 1% COG/NP0
- Target: Aluminum, 1.5 mm thickness
- Channel = Channel 0 (continuous mode)
- CLKIN = 40MHz, CHx_FIN_DIVIDER = 0x01, CHx_FREF_DIVIDER = 0x001
- CH0_RCOUNT = 0xFFFF, SETTLECOUNT_CH0 = 0x0100
- RP_OVERRIDE = 1, AUTO_AMP_DIS = 1, DRIVE_CURRENT_CH0 = 0x9800





10 Power Supply Recommendations

- The LDC requires a voltage supply within 2.7 V and 3.6 V. A multilayer ceramic bypass X7R capacitor of 1µF between the VDD and GND pins is recommended. If the supply is located more than a few inches from the LDC, additional bulk capacitance may be required in addition to the ceramic bypass capacitor. An electrolytic capacitor with a value of 10µF is a typical choice.
- The optimum placement is closest to the VDD and GND terminals of the device. Care should be taken to minimize the loop area formed by the bypass capacitor connection, the VDD terminal, and the GND terminal of the IC. See Figure 57 and Figure 58 for a layout example.

11 Layout

11.1 Layout Guidelines

Avoid long traces to connect the sensor to the LDC. Short traces reduce parasitic capacitances between sensor inductor and offer higher system performance.

11.2 Layout Example

Figure 57 to Figure 60 show the LDC1312 evaluation module (EVM) layout.

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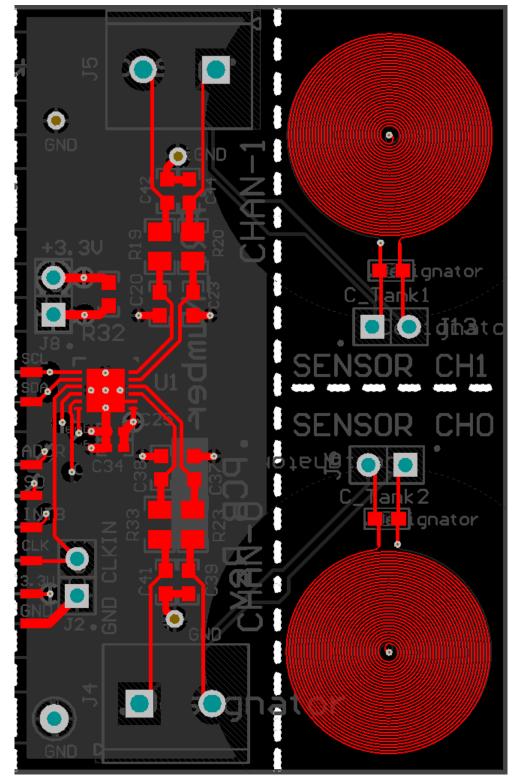


Figure 57. Example PCB Layout: Top Layer (Signal)



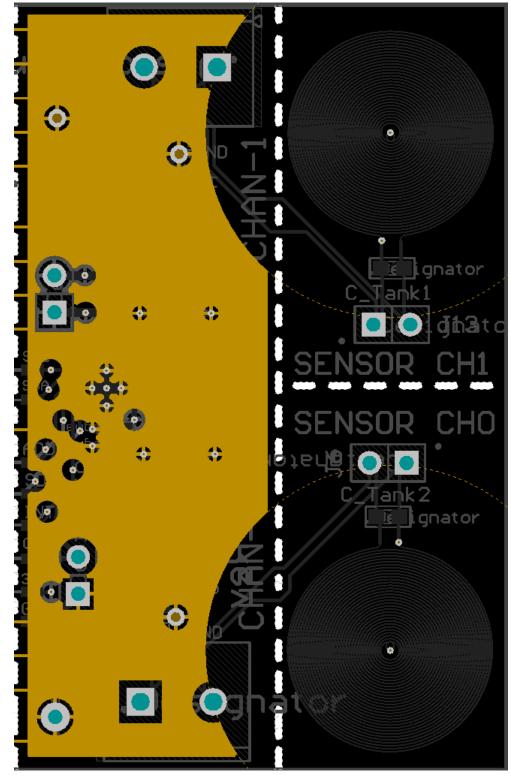


Figure 58. Example PCB Layout: Mid-layer 1 (GND)



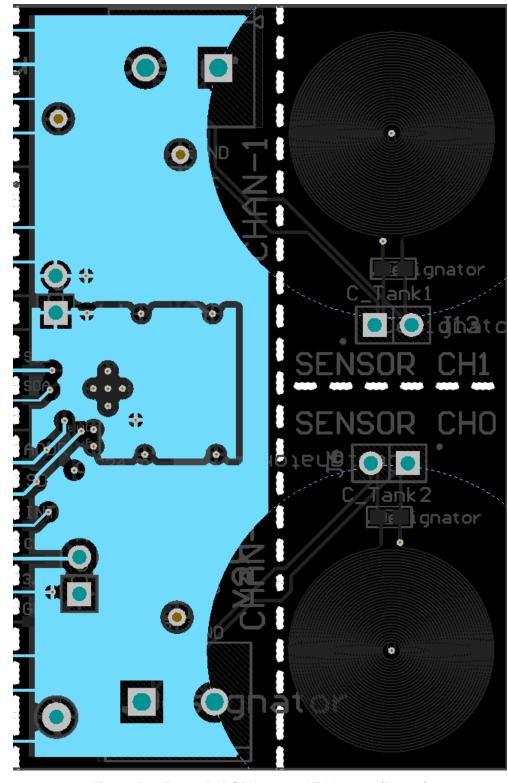


Figure 59. Example PCB Layout: Mid-layer 2 (Power)



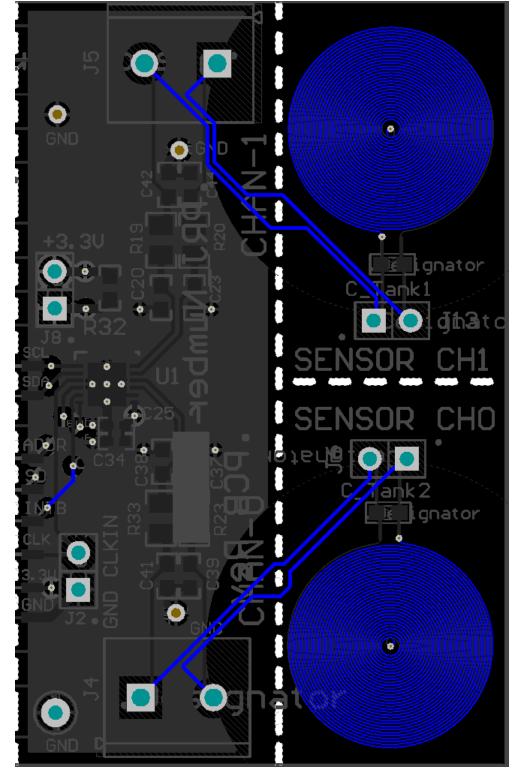


Figure 60. Example PCB Layout: Bottom Layer (Signal)



12 Device and Documentation Support

12.1 Device Support

12.1.1 Development Support

For related links, see the following:

• Texas Instruments' WEBENCH tool: http://www.ti.com/webench

12.2 Documentation Support

12.2.1 Related Documentation

For related documentation, refer to the following:

• LDC1000 Temperature Compensation (SNAA212)

12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E[™] Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.4 Related Links

The Table 46 below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

| PARTS | PRODUCT FOLDER | SAMPLE & BUY | TECHNICAL DOCUMENTS | TOOLS & SOFTWARE | SUPPORT & COMMUNITY | |
|------------|----------------|--------------|------------------------|---------------------|---------------------|--|
| LDC1312-Q1 | Click here | Click here | Click here | Click here | Click here | |
| LDC1314-Q1 | Click here | Click here | Click here | Click here | Click here | |

Table 46. Related Links

12.5 Trademarks

E2E is a trademark of Texas Instruments. WEBENCH is a registered trademark of Texas Instruments. All other trademarks are the property of their respective owners.

12.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|-------------------------------|----------------------|--------------|-------------------------|---------|
| | | | | | | | (6) | | | 1.010100 | |
| LDC1312QDNTRQ1 | ACTIVE | WSON | DNT | 12 | 4500 | RoHS & Green | SN | Level-3-260C-168 HR | -40 to 125 | LC1312Q Q1 | Samples |
| LDC1312QDNTTQ1 | ACTIVE | WSON | DNT | 12 | 250 | RoHS & Green | SN | Level-3-260C-168 HR | -40 to 125 | LDC1312 Q1 | Samples |
| LDC1314QRGHRQ1 | ACTIVE | WQFN | RGH | 16 | 4500 | RoHS & Green | SN | Level-3-260C-168 HR | -40 to 125 | LC1314Q | Samples |
| LDC1314QRGHTQ1 | ACTIVE | WQFN | RGH | 16 | 250 | RoHS & Green | SN | Level-3-260C-168 HR | -40 to 125 | LC1314Q | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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10-Dec-2020

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF LDC1312-Q1, LDC1314-Q1 :

• Catalog: LDC1312, LDC1314

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product



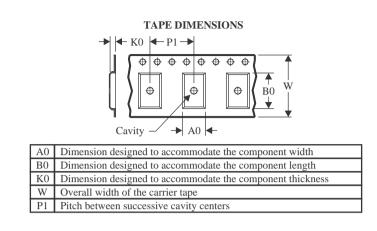
Texas

*All dimensions are nominal

STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| Device | | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|----------------|------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| LDC1312QDNTRQ1 | WSON | DNT | 12 | 4500 | 330.0 | 12.4 | 4.3 | 4.3 | 1.3 | 8.0 | 12.0 | Q1 |
| LDC1312QDNTTQ1 | WSON | DNT | 12 | 250 | 178.0 | 12.4 | 4.3 | 4.3 | 1.3 | 8.0 | 12.0 | Q1 |
| LDC1314QRGHRQ1 | WQFN | RGH | 16 | 4500 | 330.0 | 12.4 | 4.3 | 4.3 | 1.3 | 8.0 | 12.0 | Q1 |
| LDC1314QRGHTQ1 | WQFN | RGH | 16 | 250 | 178.0 | 12.4 | 4.3 | 4.3 | 1.3 | 8.0 | 12.0 | Q1 |



PACKAGE MATERIALS INFORMATION

9-Aug-2022



*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| LDC1312QDNTRQ1 | WSON | DNT | 12 | 4500 | 356.0 | 356.0 | 35.0 |
| LDC1312QDNTTQ1 | WSON | DNT | 12 | 250 | 367.0 | 367.0 | 35.0 |
| LDC1314QRGHRQ1 | WQFN | RGH | 16 | 4500 | 356.0 | 356.0 | 35.0 |
| LDC1314QRGHTQ1 | WQFN | RGH | 16 | 250 | 208.0 | 191.0 | 35.0 |

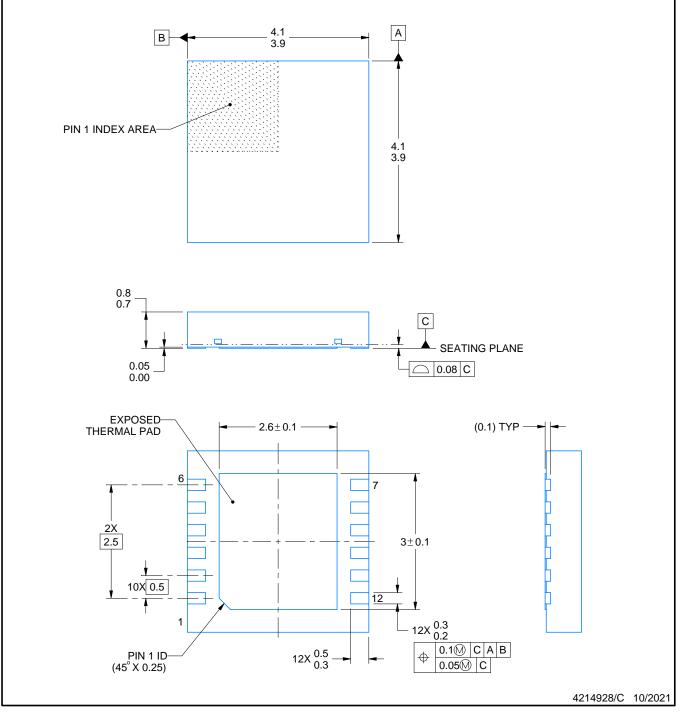
DNT0012B



PACKAGE OUTLINE

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

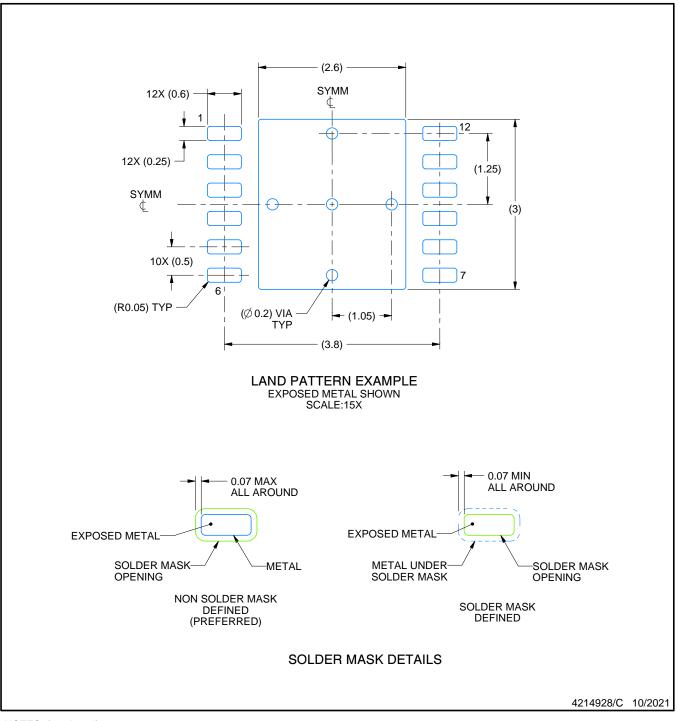


DNT0012B

EXAMPLE BOARD LAYOUT

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

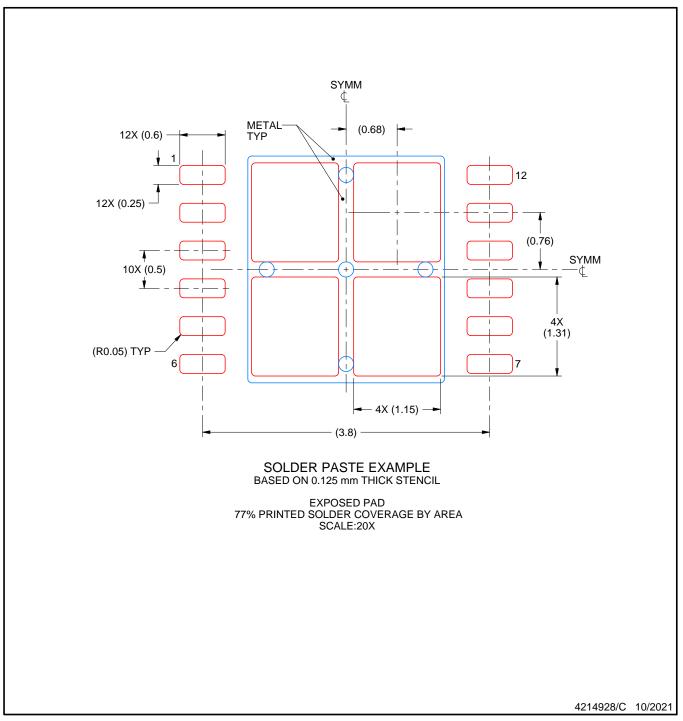


DNT0012B

EXAMPLE STENCIL DESIGN

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

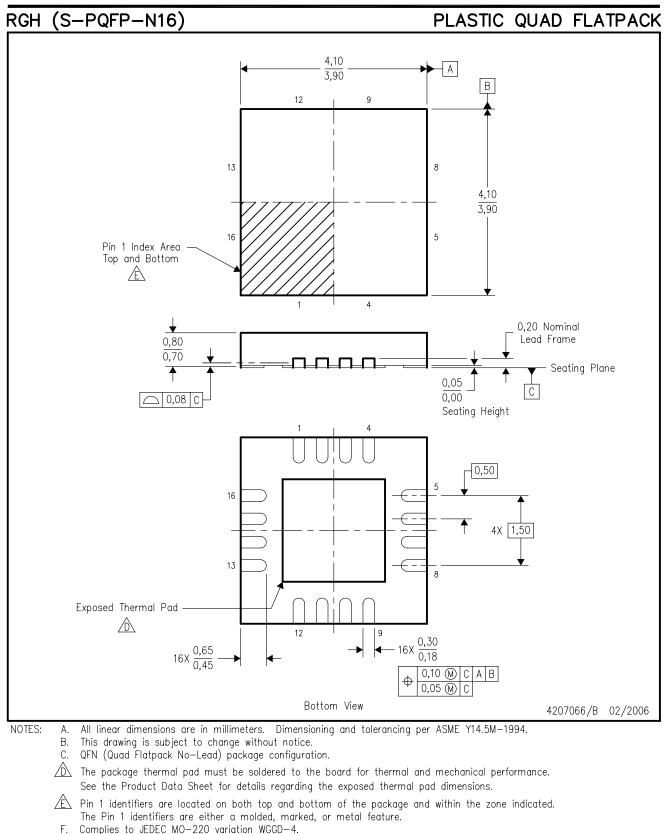


NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



MECHANICAL DATA



Complies to JEDEC MO-220 variation WGGD-4.



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